Shenzhen CTL Testing Technology Co., Ltd.
Tel: +86-755-89486194 E-mail: ctl@ctl-lab.com

TEST REPORT

FCC Part 27/RSS-130

Report Reference No. ..... :	**CTL1907151031-WF04**	
Compiled by: (position+printed name+signature)	Happy Guo (File administrators)	Happy Guo
Tested by: (position+printed name+signature)	Nice Nong (Test Engineer)	Nice Nong
Approved by: (position+printed name+signature)	Ivan Xie (Manager)	Ivan Xie

Product Name ..... :	Multifunctional intelligent cabinet
Model/Type reference ..... :	UC1901
List Model(s)..... :	N/A
Trade Mark..... :	N/A
FCC ID..... :	**2AU8G-UC1901**
IC..... :	**25685-UC1901**
Applicant's name ..... :	**SUZHOU DUSIT TECHNOLOGY CO., LTD**
Address of applicant ..... :	NO.289 SOUTH YINZHONG RD, WUZHONG ECONOMIC DISTRICT, SUZHOU, CHINA
Test Firm..... :	**Shenzhen CTL Testing Technology Co., Ltd.**
Address of Test Firm ..... :	Floor 1-A, Baisha Technology Park, No.3011, Shahexi Road, Nanshan District, Shenzhen, China 518055
Test specification..... :	
Standard ..... :	**FCC CFR Title 47 Part 2, Part 27** **EIA/TIA 603-D: 2010** **KDB 971168 D01** **RSS-130 Issue 2 February 2019**
TRF Originator ..... :	Shenzhen CTL Testing Technology Co., Ltd.
Master TRF..... :	Dated 2011-01
Date of receipt of test item ..... :	Jul. 20, 2019
Date of sampling..... :	Jul. 20, 2019
Date of Test Date..... :	Jul. 20, 2019–Sep. 28, 2019
Data of Issue..... :	Sep. 29, 2019
Result..... :	**Pass**

TEST REPORT

Test Report No. :	CTL1907151031-WF04	Sep. 29, 2019 Date of issue

Equipment under Test	:	Multifunctional intelligent cabinet
Model /Type	:	UC1901
Listed Models	:	N/A
Applicant	:	**SUZHOU DUSIT TECHNOLOGY CO., LTD**
Address	:	NO.289 SOUTH YINZHONG RD, WUZHONG ECONOMIC DISTRICT, SUZHOU, CHINA
Manufacturer	:	**SUZHOU DUSIT TECHNOLOGY CO., LTD**
Address	:	NO.289 SOUTH YINZHONG RD, WUZHONG ECONOMIC DISTRICT, SUZHOU, CHINA

Test result	Pass *

*In the configuration tested, the EUT complied with the standards specified page 5.

The test results presented in this report relate only to the object tested.
This report shall not be reproduced, except in full, without the written approval of the issuing testing laboratory.

** Modified History **

Revisions	Description	Issued Data	Report No.	Remark
Version 1.0	Initial Test Report Release	2019-09-29	CTL1907151031-WF04	Tracy Qi

Table of Contents Page

1. SUMMARY

1.1. TEST STANDARDS

The tests were performed according to following standards:
FCC Part 27 : MISCELLANEOUS WIRELESS COMMUNICATIONS SERVICES
TIA/EIA 603 D June 2010:Land Mobile FM or PM Communications Equipment Measurement and Performance Standards.
FCC Part 2: FREQUENCY ALLOCA-TIONS AND RADIO TREATY MAT-TERS; GENERAL RULES AND REG-ULATIONS
KDB971168 D01: v02r02 MEASUREMENT GUIDANCE FOR CERTIFICATION OF LICENSED DIGITAL TRANSMITTERS
ANSI C63.10: 2013: American National Standard for Testing Unlicensed Wireless Devices

ANSI C63.4: 2014: –American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40GHz Range of 9 kHz to 40GHz

RSS-Gen Issue 4: General Requirements for Compliance of Radio Apparatus
RSS-130 Issue 2: Equipment Operating in the Frequency Bands 617-652 MHz, 663-698 MHz, 698-756 MHz and 777-787 MHz
SRSP-518: Technical Requirements in the Bands 617-652 MHz, 663-698 MHz, 698-756 MHz and 777-787 MHz Issue 2, February 2019

1.2. Test Description

Test Item	Section in CFR 47	Result
RF Output Power	Part 2.1046 Part 27.50(d)(4) RSS 130 4.6	Pass
Peak-to-Average Ratio	Part 27.50(d)(4) RSS 130 4.6	Pass
99% & -26 dB Occupied Bandwidth	Part 2.1049 Part 27.53(h) RSS-GEN 6.7	Pass
Spurious Emissions at Antenna Terminal	Part 2.1051 Part 27.53(h) RSS 130 4.7	Pass
Field Strength of Spurious Radiation	Part 2.1053 Part 27.53(h) RSS 130 4.7	Pass
Out of band emission, Band Edge	Part 2.1051 Part 27.53(h) RSS 130 4.7	Pass
Frequency stability	Part 2.1055 Part 27.54 RSS 130 4.5	Pass

1.3. Test Facility

1.3.1 Address of the test laboratory

Shenzhen CTL Testing Technology Co., Ltd.
Floor 1-A, Baisha Technology Park, No. 3011, Shahexi Road, Nanshan, Shenzhen 518055 China

There is one 3m semi-anechoic chamber and two line conducted labs for final test. The Test Sites meet the requirements in documents ANSI C63.4 and CISPR 32/EN 55032 requirements.

1.3.2 Laboratory accreditation

The test facility is recognized, certified, or accredited by the following organizations:

CNAS-Lab Code: L7497

Shenzhen CTL Testing Technology Co., Ltd. has been assessed and proved to be in compliance with CNAS-CL01 Accreditation Criteria for Testing and Calibration Laboratories (identical to ISO/IEC 17025: 2005 General Requirements) for the Competence of Testing and Calibration Laboratories.

A2LA-Lab Cert. No. 4343.01

Shenzhen CTL Testing Technology Co., Ltd, EMC Laboratory has been accredited by A2LA for technical competence in the field of electrical testing, and proved to be in compliance with ISO/IEC 17025: 2005 General Requirements for the Competence of Testing and Calibration Laboratories and any additional program requirements in the identified field of testing.

IC Registration No.: 9618B

CAB identifier: CN0041

The 3m alternate test site of Shenzhen CTL Testing Technology Co., Ltd. EMC Laboratory has been registered by Innovation, Science and Economic Development Canada to test to Canadian radio equipment requirements with Registration No.: 9618B on Jan. 22, 2019.

FCC-Registration No.: 399832

Designation No.: CN1216

Shenzhen CTL Testing Technology Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration 399832, December 08, 2017.

1.4. Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to CISPR 16 - 4 “Specification for radio disturbance and immunity measuring apparatus and methods – Part 4: Uncertainty in EMC Measurements“ and is documented in the Shenzhen CTL Testing Technology Co., Ltd. quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

Hereafter the best measurement capability for CTL laboratory is reported:

Test	Range	Measurement Uncertainty	Notes
Radiated Emission	30~1000MHz	4.10dB	(1)
Radiated Emission	Above 1GHz	4.32dB	(1)
Conducted Disturbance	0.15~30MHz	3.20dB	(1)

(1) This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

2. GENERAL INFORMATION

2.1. Environmental conditions

During the measurement the environmental conditions were within the listed ranges:

Normal Temperature:	25°C
Relative Humidity:	55 %
Air Pressure:	101 kPa

2.2. General Description of EUT

Product Name:	Multifunctional intelligent cabinet
Model/Type reference:	UC1901
Power supply:	DC 12V From Adapter
Adapter information:	Model: EADP-30FB A Input: 100-240V~, 50/60Hz, 1A Output: 12V⎓3.0A
Hardware version:	V1.0
Software version:	V1.0
LTE	
Operation Band:	FDD-LTE: Band 2/4/7/12
Modulation Type:	QPSK, 16QAM
Release Version:	Release 9
Category:	Cat 4
Antenna Type:	External antenna
Antenna Gain:	0 dBi

Note: For more details, please refer to the user's manual of the EUT.

2.3. Description of Test Modes

The EUT has been tested under typical operating condition. The CMW500 used to control the EUT staying in continuous transmitting and receiving mode for testing. Regards to the frequency band operation: the lowest、middle and highest frequency of channel were selected to perform the test, then shown on this report.

2.4. Equipments Used during the Test

Test Equipment	Manufacturer	Model No.	Serial No.	Calibration Date	Calibration Due Date
Bilog Antenna	Sunol Sciences Corp.	JB1	A061713	2019/05/20	2020/05/19
Bilog Antenna	Sunol Sciences Corp.	JB1	A061714	2019/05/20	2020/05/19
EMI Test Receiver	R&S	ESCI	103710	2019/05/20	2020/05/19
Spectrum Analyzer	Agilent	E4407B	MY41440676	2019/05/20	2020/05/19
Spectrum Analyzer	Agilent	N9020	US46220290	2019/05/20	2020/05/19
Controller	EM Electronics	Controller EM 1000	N/A	2019/05/20	2020/05/19
Horn Antenna	Sunol Sciences Corp.	DRH-118	A062013	2019/05/20	2020/05/19

Horn Antenna	Sunol Sciences Corp.	DRH-118	A062014	2019/05/20	2020/05/19
Active Loop Antenna	SCHWARZBECK	FMZB1519	1519-037	2019/05/20	2020/05/19
Amplifier	Agilent	8349B	3008A02306	2019/05/20	2020/05/19
Amplifier	Agilent	8447D	2944A10176	2019/05/20	2020/05/19
Temperature/Humidity Meter	Gangxing	CTH-608	02	2019/05/20	2020/05/19
Wideband Radio Communication Tester	R&S	CMW500	101814	2019/05/20	2020/05/19
High-Pass Filter	K&L	9SH10-2700/X12750-O/O	N/A	2019/05/20	2020/05/19
High-Pass Filter	K&L	41H10-1375/U12750-O/O	N/A	2019/05/20	2020/05/19
RF Cable	HUBER+SUHNER	RG214	N/A	2019/05/20	2020/05/19
Climate Chamber	ESPEC	EL-10KA	A20120523	2019/05/20	2020/05/19
SIGNAL GENERATOR	Agilent	E4421B	US40051744	2019/05/20	2020/05/19
Directional Coupler	Agilent	87300B	3116A03638	2019/05/20	2020/05/19

The calibration interval was one year

2.5. Related Submittal(s) / Grant (s)

This submittal(s) (test report) is intended to comply with of the Part 27 and RSS-130 Rules.

2.6. Modifications

No modifications were implemented to meet testing criteria.

3. TEST CONDITIONS AND RESULTS

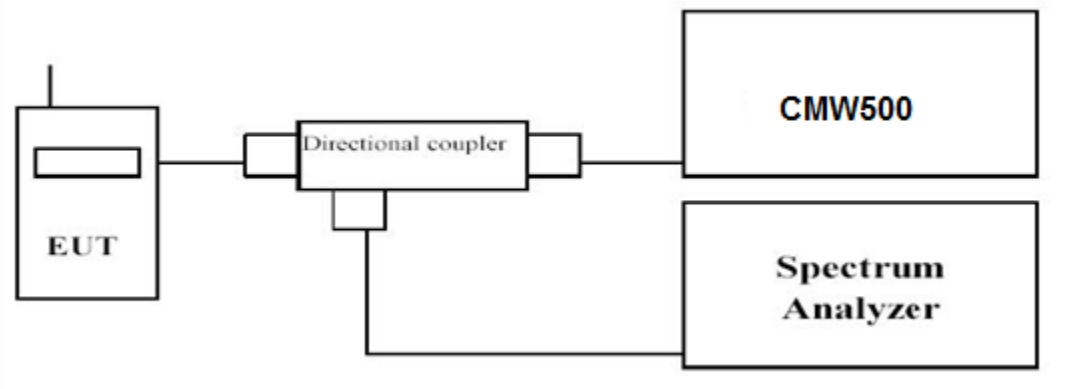
3.1. Output Power

LIMIT

1 watt EIRP.

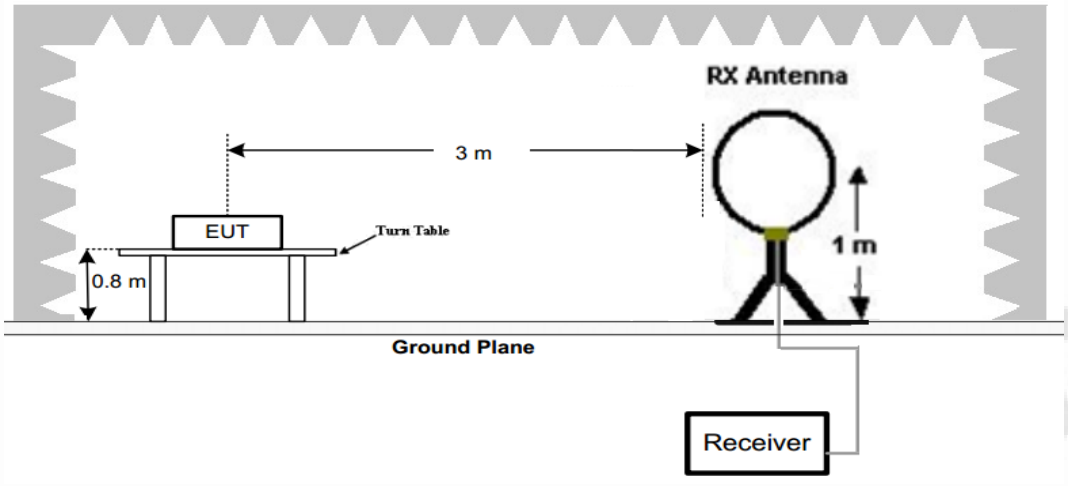
TEST CONFIGURATION

Conducted Power Measurement

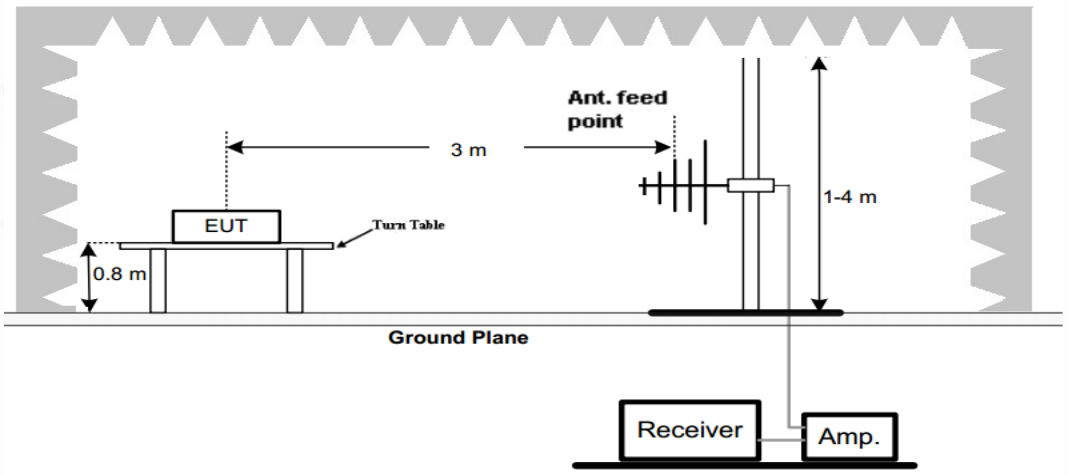


Radiated Power Measurement:

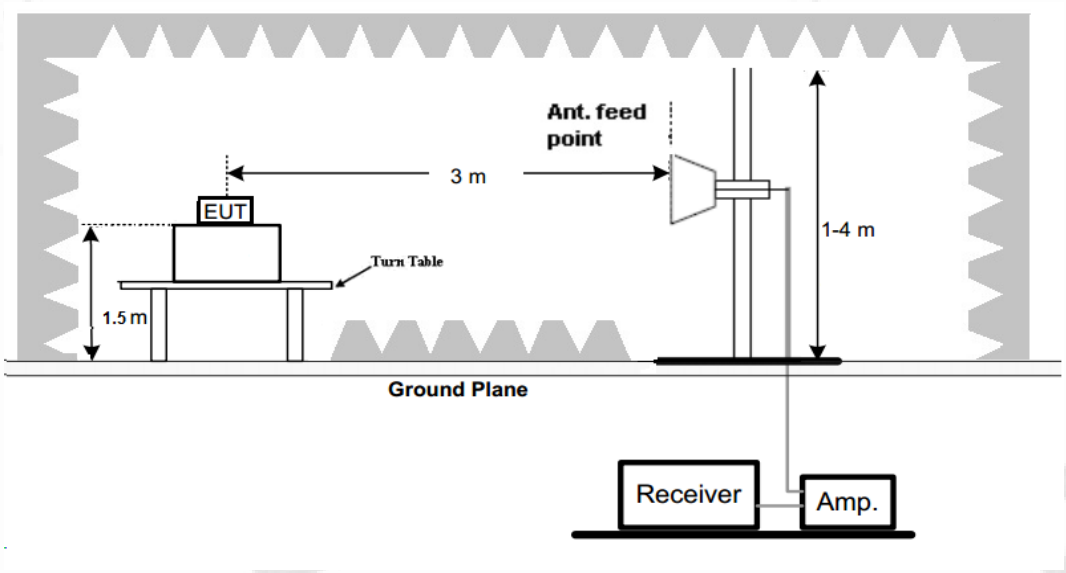
(A) Radiated Emission Test Set-Up, Frequency Below 30MHz



(B) Radiated Emission Test Set-Up, Frequency below 1000MHz



(C) Radiated Emission Test Set-Up, Frequency above 1000MHz



TEST PROCEDURE

The EUT was setup according to EIA/TIA 603D

Conducted Power Measurement:

a) Place the EUT on a bench and set it in transmitting mode.
b) Connect a low loss RF cable from the antenna port to a spectrum analyzer and CMW500 by a Directional Couple.
c) EUT Communicate with CMW500 then selects a channel for testing.
d) Add a correction factor to the display of spectrum, and then test.

Radiated Power Measurement:

a) The EUT shall be placed at the specified height on a support, and in the position closest to normal use as declared by provider.
b) The test antenna shall be oriented initially for vertical polarization and shall be chosen to correspond to the frequency of the transmitter
c) The output of the test antenna shall be connected to the measuring receiver.
d) The transmitter shall be switched on and the measuring receiver shall be tuned to the frequency of the transmitter under test.
e) The test antenna shall be raised and lowered through the specified range of height until a maximum signal level is detected by the measuring receiver.
f) The transmitter shall then be rotated through 360° in the horizontal plane, until the maximum signal level is detected by the measuring receiver.
g) The test antenna shall be raised and lowered again through the specified range of height until a maximum signal level is detected by the measuring receiver.
h) The maximum signal level detected by the measuring receiver shall be noted.
i) The transmitter shall be replaced by a substitution antenna.
j) The substitution antenna shall be orientated for vertical polarization and the length of the substitution antenna shall be adjusted to correspond to the frequency of the transmitter.
k) The substitution antenna shall be connected to a calibrated signal generator.

l) If necessary, the input attenuator setting of the measuring receiver shall be adjusted in order to increase the sensitivity of the measuring receiver.

m) The test antenna shall be raised and lowered through the specified range of height to ensure that the maximum signal is received.

n) The input signal to the substitution antenna shall be adjusted to the level that produces a level detected by the measuring receiver, that is equal to the level noted while the transmitter radiated power was measured, corrected for the change of input attenuator setting of the measuring receiver.

o) The measurement shall be repeated with the test antenna and the substitution antenna orientated for horizontal polarization.

p) The measure of the effective radiated power is the larger of the two levels recorded at the input to the substitution antenna, corrected for gain of the substitution antenna if necessary.

q) Test site anechoic chamber refer to ANSI C63.4.

TEST RESULTS

Conducted Measurement:

LTE FDD Band 12					
TX Channel Bandwidth	Frequency (MHz)	RB Configuration		RB Configuration	
		Size	Size	QPSK	16QAM
1.4 MHz	699.7	1	0	22.85	22.50
		1	3	23.47	23.47
		1	5	21.65	22.21
		3	0	23.31	22.62
		3	2	23.32	23.48
		3	3	22.38	23.08
		6	0	23.31	21.99
	707.5	1	0	22.19	22.57
		1	3	22.59	22.09
		1	5	22.05	23.30
		3	0	22.36	22.17
		3	2	22.18	21.79
		3	3	21.57	21.98
		6	0	21.64	23.45
	715.3	1	0	22.16	22.70
		1	3	22.78	23.04
		1	5	22.43	22.98
		3	0	22.20	22.58
		3	2	22.02	21.58
		3	3	22.18	22.16
		6	0	21.63	23.38
3 MHz	700.5	1	0	22.81	21.93
		1	3	21.93	22.23
		1	5	21.66	22.01
		3	0	21.83	21.64
		3	2	23.37	21.72
		3	3	21.56	21.70
		6	0	22.93	22.49
	707.5	1	0	21.83	22.64
		1	3	22.21	22.73
		1	5	22.57	22.67
		3	0	22.05	23.19
		3	2	21.96	23.03
		3	3	22.49	22.27
		6	0	22.10	22.35
	714.5	1	0	22.08	22.55
		1	3	21.56	21.78
		1	5	23.03	23.17
		3	0	23.30	21.88
		3	2	21.89	21.95
		3	3	23.19	21.99
		6	0	21.62	23.14
5 MHz	701.5	1	0	22.51	22.62
		1	3	22.56	22.88
		1	5	22.74	22.70
		3	0	22.07	22.38
		3	2	22.02	22.80
		3	3	23.16	23.05
		6	0	22.88	22.93
	707.5	1	0	22.67	21.62
		1	3	22.06	21.66

		1	5	22.80	21.96
		3	0	22.34	22.53
		3	2	21.68	22.76
		3	3	21.79	22.25
		6	0	23.12	21.67
	713.5	1	0	21.88	22.54
		1	3	22.34	21.81
		1	5	22.87	23.04
		3	0	21.56	21.53
		3	2	22.59	22.47
		3	3	21.78	23.31
		6	0	22.00	22.13
10 MHz	704	1	0	22.47	22.31
		1	3	21.89	23.07
		1	5	23.17	22.09
		3	0	22.60	23.00
		3	2	22.27	22.91
		3	3	22.51	22.14
		6	0	22.02	22.70
	707.5	1	0	22.32	21.93
		1	3	21.89	22.83
		1	5	21.66	23.41
		3	0	23.26	23.33
		3	2	21.63	23.26
		3	3	23.19	22.98
		6	0	22.87	22.79
	711	1	0	21.65	23.14
		1	3	21.56	23.04
		1	5	23.18	22.83
		3	0	22.62	22.01
		3	2	23.02	22.08
		3	3	22.02	23.23
		6	0	22.73	22.97

Radiated Measurement:

Remark:

1. *We were tested all RB Configuration refer 3GPP TS136 521 for each Channel Bandwidth of LTE FDD Band 12; recorded worst case for each Channel Bandwidth of LTE FDD Band 12.*
2. *EIRP=P_{Mea}(dBm)-P_{cl}(dB)+P_{Ag}(dB)+G_a(dBi)*

LTE FDD Band 12_Channel Bandwidth 1.4MHz_QPSK

Frequency (MHz)	P_{Mea} (dBm)	P_{cl} (dB)	G_a Antenna Gain(dB)	P_{Ag} (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
699.7	-18.14	1.87	8.20	36.33	24.52	30.00	5.48	V
707.5	-17.67	1.88	8.34	36.32	25.11	30.00	4.89	V
715.3	-17.87	1.90	8.48	36.31	25.02	30.00	4.98	V

LTE FDD Band 12_Channel Bandwidth 3MHz_QPSK

Frequency (MHz)	P_{Mea} (dBm)	P_{cl} (dB)	G_a Antenna Gain(dB)	P_{Ag} (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
700.5	-17.54	1.87	8.20	36.33	25.12	30.00	4.88	V
707.5	-17.54	1.88	8.34	36.32	25.24	30.00	4.76	V
714.5	-17.91	1.90	8.48	36.31	24.98	30.00	5.02	V

LTE FDD Band 12_Channel Bandwidth 5MHz_QPSK

Frequency (MHz)	P_{Mea} (dBm)	P_{cl} (dB)	G_a Antenna Gain(dB)	P_{Ag} (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
701.5	-18.54	1.87	8.20	36.33	24.12	30.00	5.88	V
707.5	-18.55	1.88	8.34	36.32	24.23	30.00	5.77	V
713.5	-17.64	1.90	8.48	36.31	25.25	30.00	4.75	V

LTE FDD Band 12_Channel Bandwidth 10MHz_QPSK

Frequency (MHz)	P_{Mea} (dBm)	P_{cl} (dB)	G_a Antenna Gain(dB)	P_{Ag} (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
704	-17.43	1.87	8.20	36.33	25.23	30.00	4.77	V
707.5	-18.20	1.88	8.34	36.32	24.58	30.00	5.42	V
711	-18.02	1.90	8.48	36.31	24.87	30.00	5.13	V

LTE FDD Band 12_Channel Bandwidth 1.4MHz_16QAM

Frequency (MHz)	P_{Mea} (dBm)	P_{cl} (dB)	G_a Antenna Gain(dB)	P_{Ag} (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
699.7	-18.54	1.87	8.20	36.33	24.12	30.00	5.88	V
707.5	-18.53	1.88	8.34	36.32	24.25	30.00	5.75	V
715.3	-18.56	1.90	8.48	36.31	24.33	30.00	5.67	V

LTE FDD Band 12_Channel Bandwidth 3MHz_16QAM

Frequency (MHz)	P_{Mea} (dBm)	P_{cl} (dB)	G_a Antenna Gain(dB)	P_{Ag} (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
700.5	-18.81	1.87	8.20	36.33	23.85	30.00	6.15	V
707.5	-18.56	1.88	8.34	36.32	24.22	30.00	5.78	V
714.5	-18.37	1.90	8.48	36.31	24.52	30.00	5.48	V

LTE FDD Band 12_Channel Bandwidth 5MHz_16QAM

Frequency (MHz)	P_{Mea} (dBm)	P_{cl} (dB)	G_a Antenna Gain(dB)	P_{Ag} (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
701.5	-18.43	1.87	8.20	36.33	24.23	30.00	5.77	V
707.5	-18.26	1.88	8.34	36.32	24.52	30.00	5.48	V
713.5	-18.26	1.90	8.48	36.31	24.63	30.00	5.37	V

LTE FDD Band 12_Channel Bandwidth 10MHz_16QAM

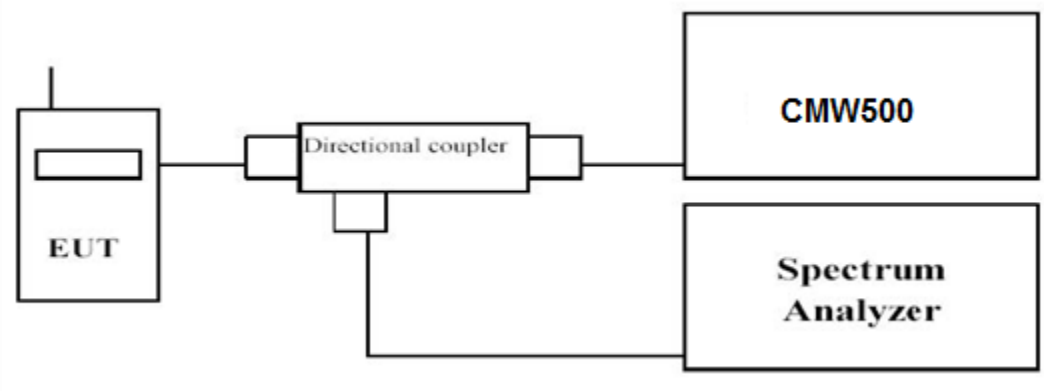
Frequency (MHz)	P_{Mea} (dBm)	P_{cl} (dB)	G_a Antenna Gain(dB)	P_{Ag} (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
704	-18.33	1.87	8.20	36.33	24.33	30.00	5.67	V
707.5	-18.13	1.88	8.34	36.32	24.65	30.00	5.35	V
711	-18.18	1.90	8.48	36.31	24.71	30.00	5.29	V

3.2. Peak-to-Average Ratio (PAR)

LIMIT

The Peak-to-Average Ratio (PAR) of the transmission may not exceed 13 dB.

TEST CONFIGURATION



TEST PROCEDURE

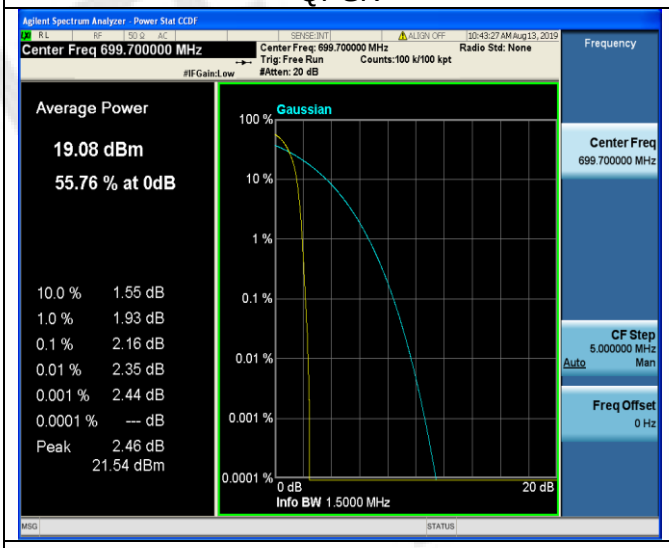
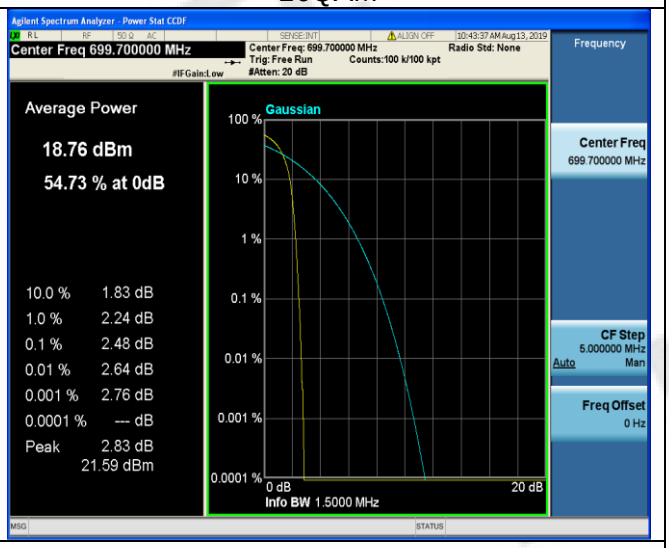
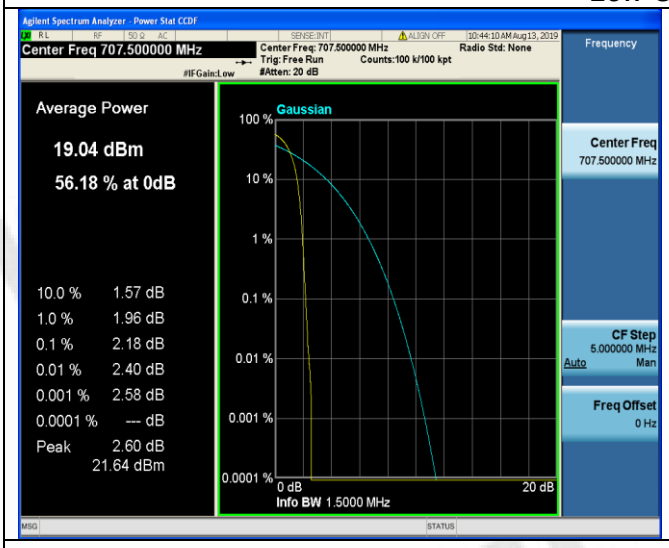
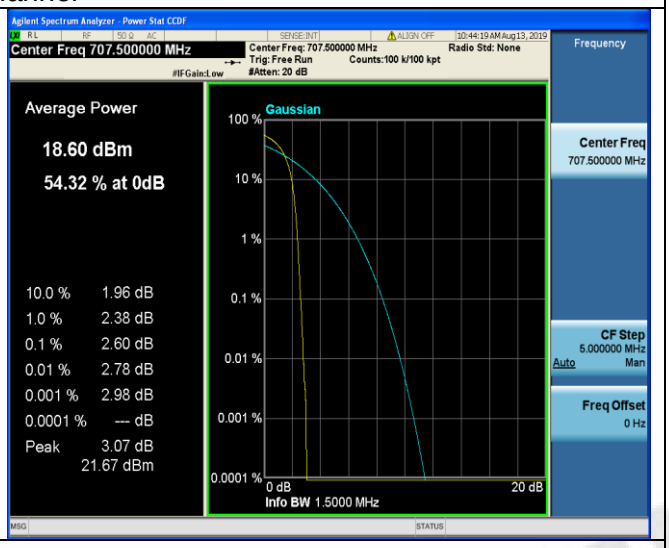
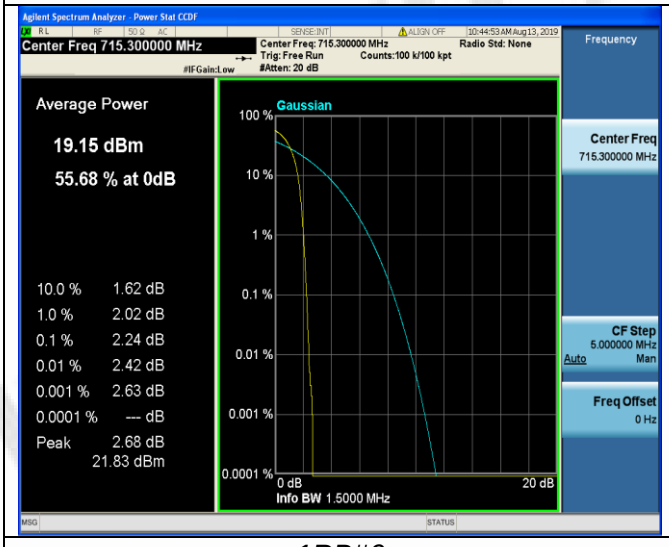
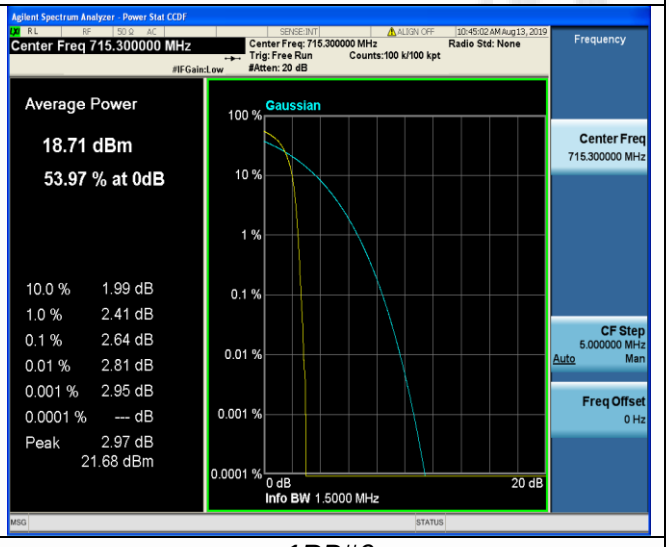
1. Refer to instrument's analyzer instruction manual for details on how to use the power statistics/CCDF function;
2. Set resolution/measurement bandwidth ≥ signal's occupied bandwidth;
3. Set the number of counts to a value that stabilizes the measured CCDF curve;
4. Set the measurement interval as follows:
   1). for continuous transmissions, set to 1 ms,
   2). for burst transmissions, employ an external trigger that is synchronized with the EUT burst timing sequence, or use the internal burst trigger with a trigger level that allows the burst to stabilize and set the measurement interval to a time that is less than or equal to the burst duration.
5. Record the maximum PAPR level associated with a probability of 0.1%.

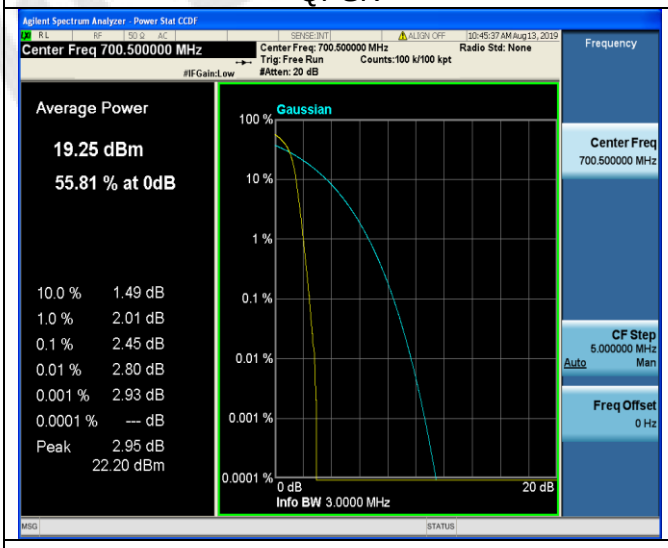
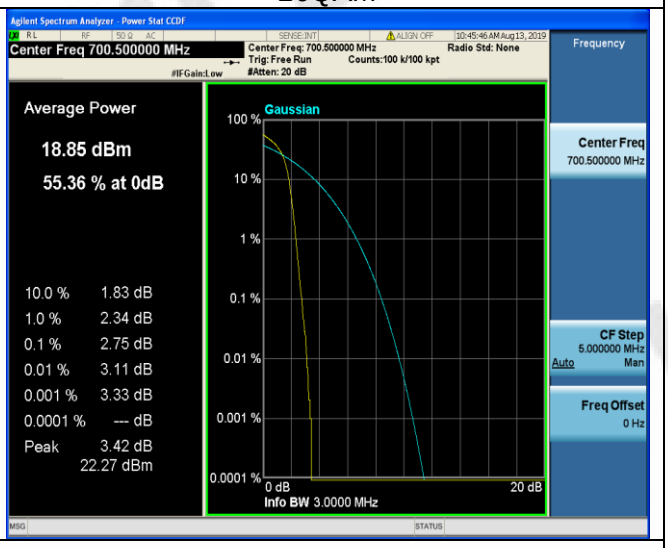
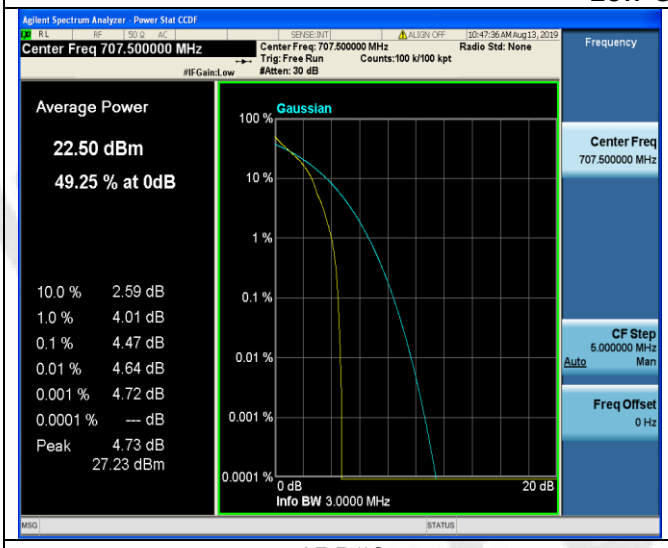
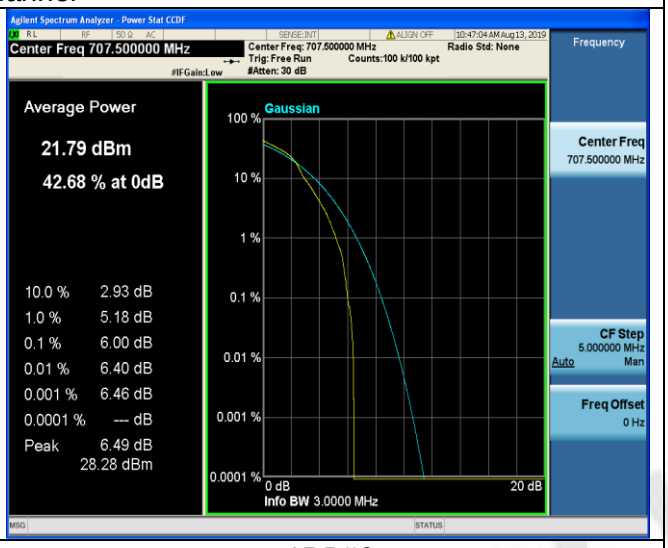
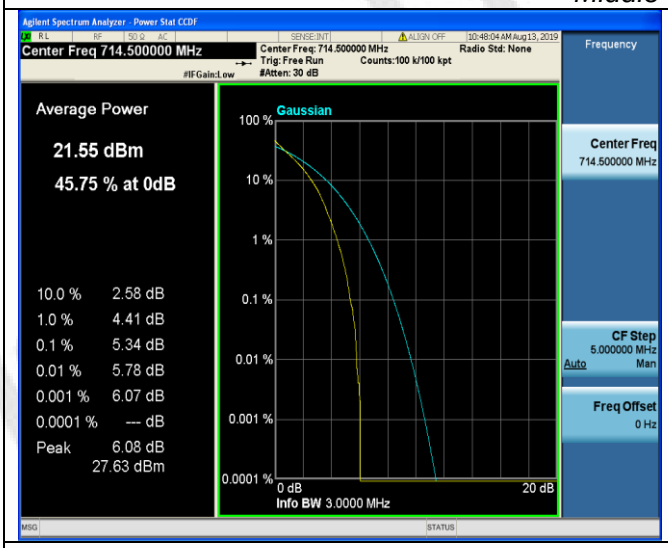
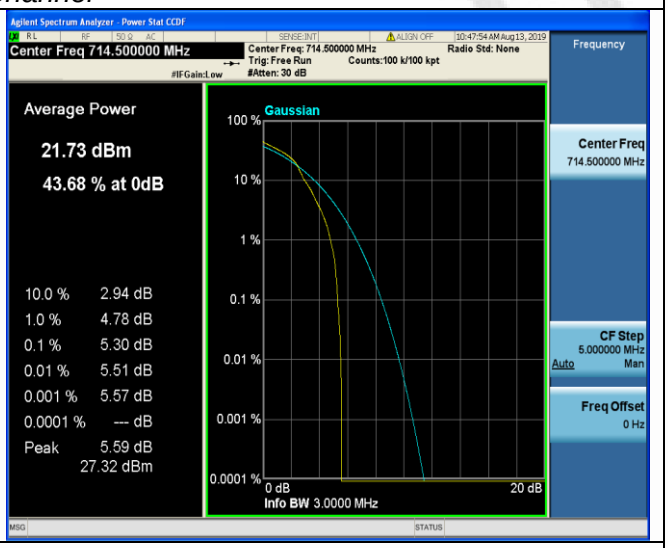
TEST RESULTS

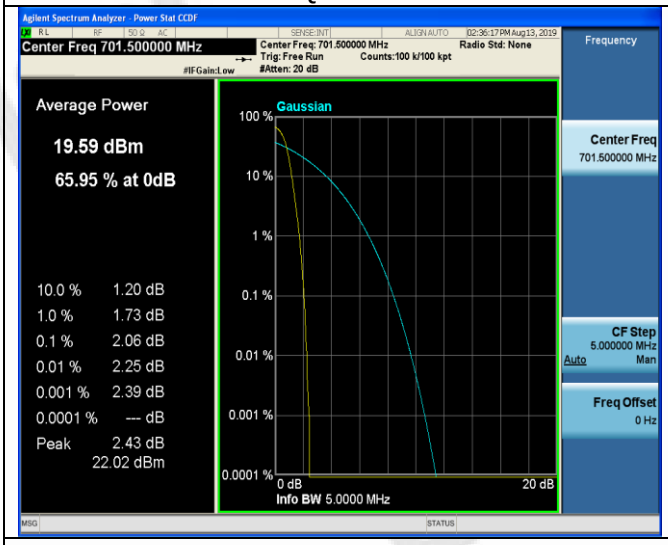
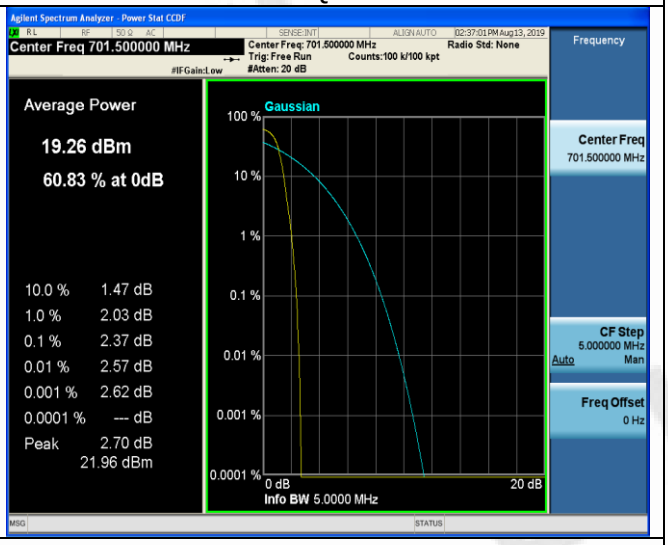
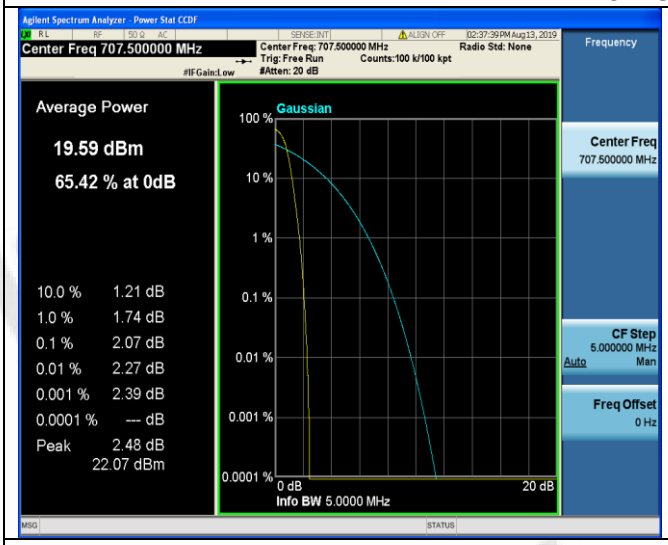
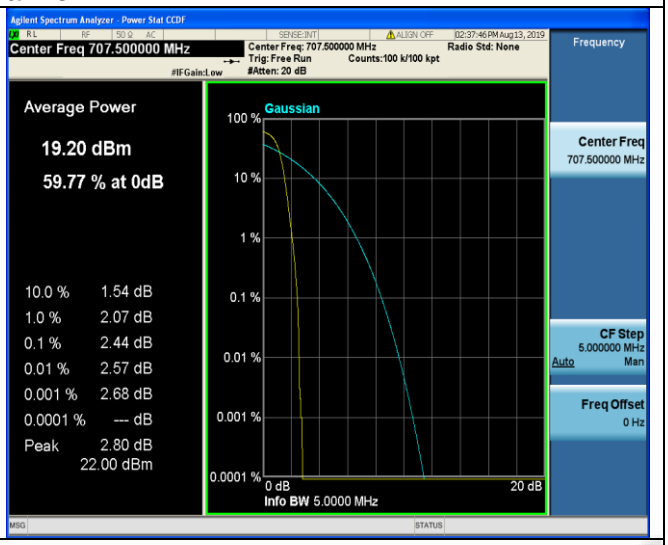
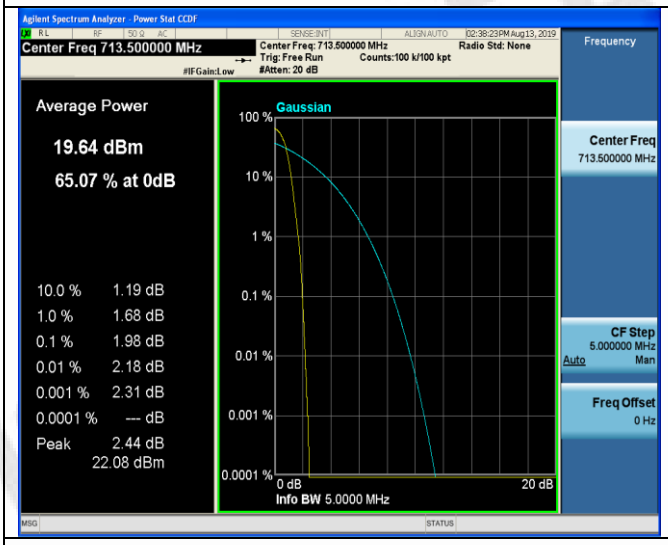
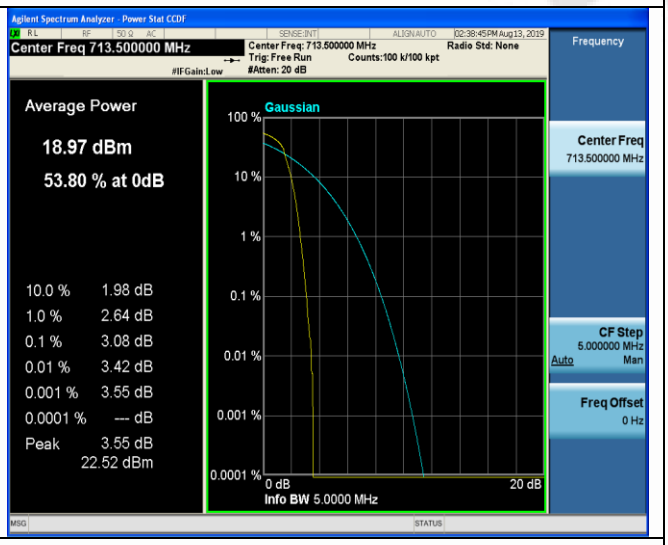
Remark:

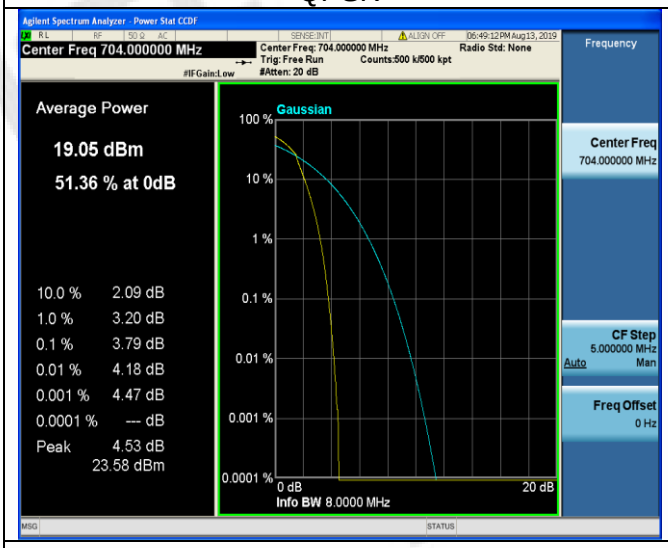
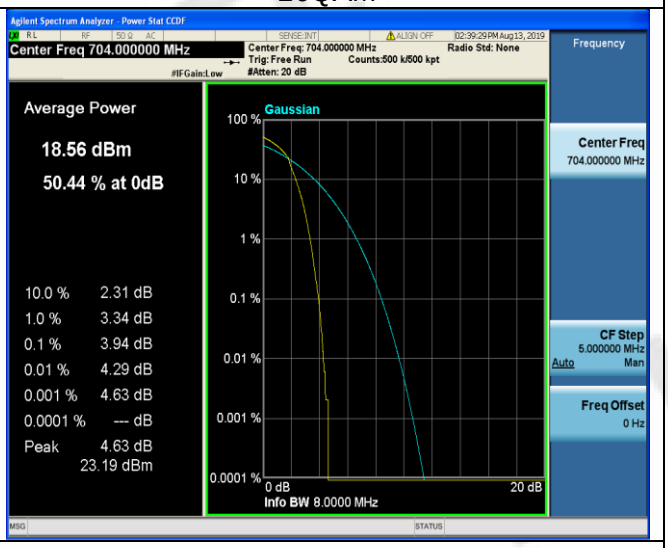
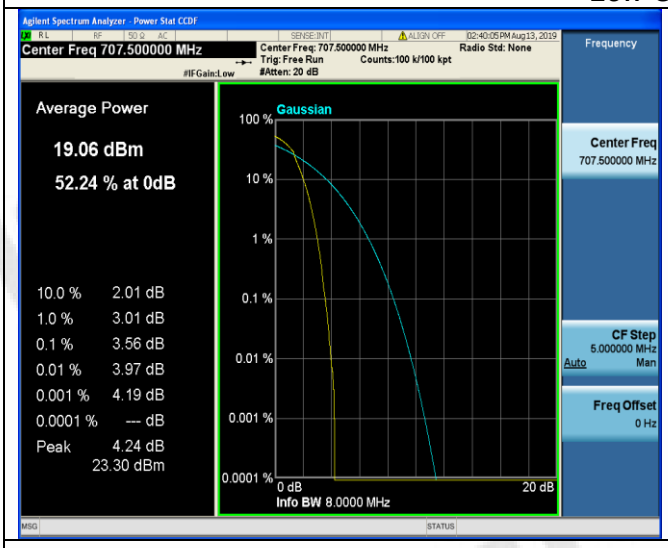
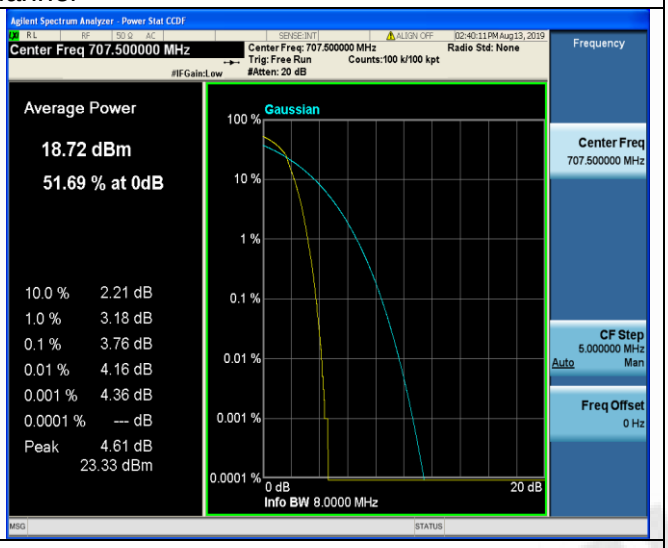
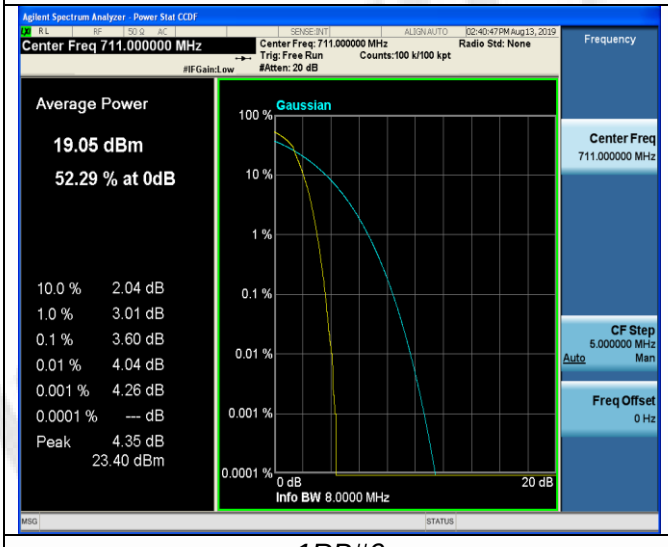
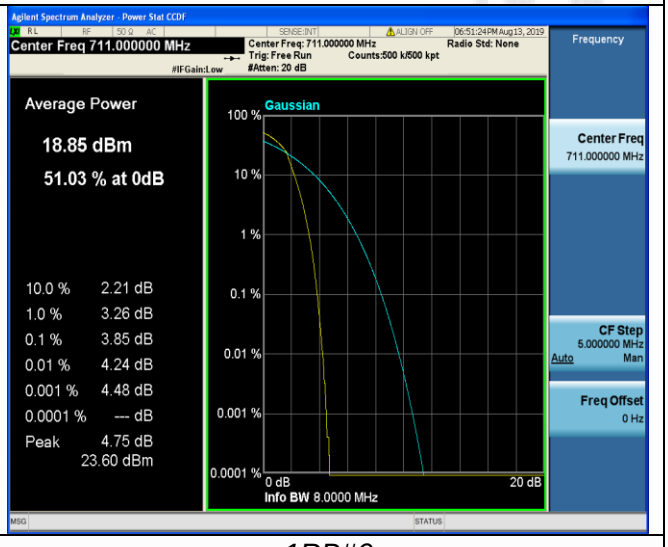
1. *We were tested all RB Configuration refer 3GPP TS136 521 for each Channel Bandwidth of LTE FDD Band 12; recorded worst case for each Channel Bandwidth of LTE FDD Band 12.*

LTE FDD Band 12				
TX Channel Bandwidth	Frequency (MHz)	RB Size/Offset	PAPR (dB)	
			QPSK	16QAM
1.4 MHz	699.7	*1RB#0*	2.16	2.48
	707.5		2.00	2.36
	715.3		2.76	3.04
3 MHz	700.5	*1RB#0*	3.68	4.10
	707.5		2.18	2.60
	714.5		2.06	2.46
5 MHz	701.5	*1RB#0*	2.71	3.08
	707.5		3.61	4.13
	713.5		2.24	2.64
10 MHz	704	*1RB#0*	2.09	2.51
	707.5		2.77	3.16
	711		3.72	4.20

LTE FDD Band 12-1.4MHz Channel Bandwidth PAPR	
QPSK	16QAM
	
1RB#0	1RB#0
Low Channel	
	
1RB#0	1RB#0
Middle Channel	
	
1RB#0	1RB#0
High Channel	

LTE FDD Band 12-3MHz Channel Bandwidth PAPR	
QPSK	16QAM
	
1RB#0	1RB#0
Low Channel	
	
1RB#0	1RB#0
Middle Channel	
	
1RB#0	1RB#0
High Channel	

LTE FDD Band 12-5MHz Channel Bandwidth PAPR	
QPSK	16QAM
	
1RB#0	1RB#0
Low Channel	
	
1RB#0	1RB#0
Middle Channel	
	
1RB#0	1RB#0
High Channel	

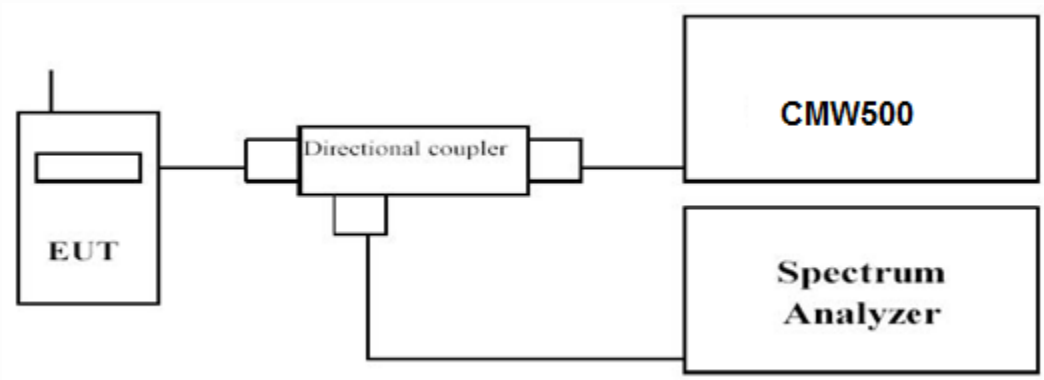
LTE FDD Band 12-10MHz Channel Bandwidth PAPR	
QPSK	16QAM
	
1RB#0	1RB#0
Low Channel	
	
1RB#0	1RB#0
Middle Channel	
	
1RB#0	1RB#0
High Channel	

3.3. Occupied Bandwidth and Emission Bandwidth

LIMIT

N/A

TEST CONFIGURATION



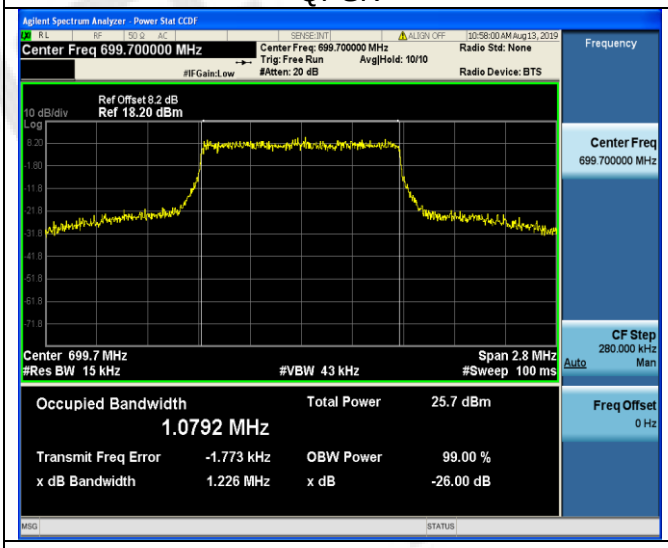
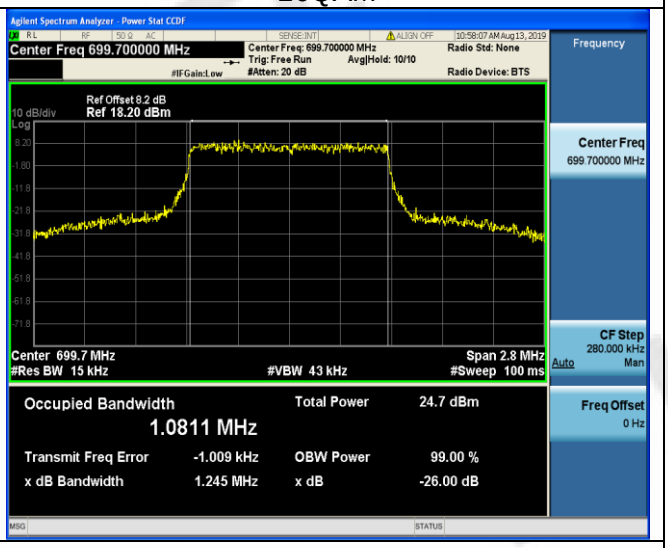
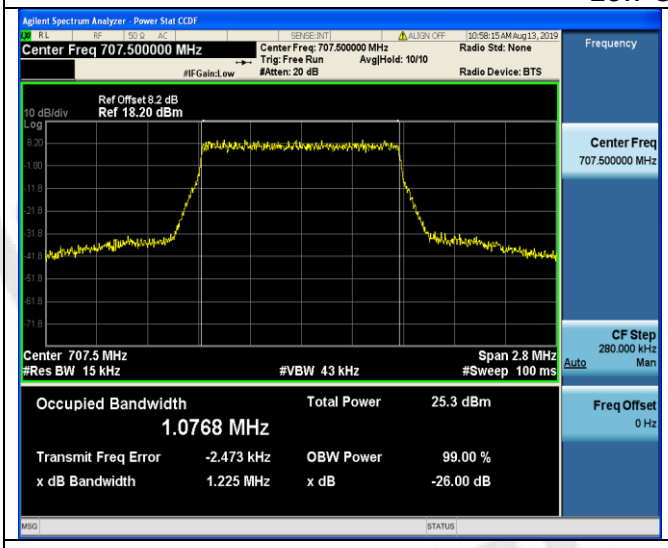
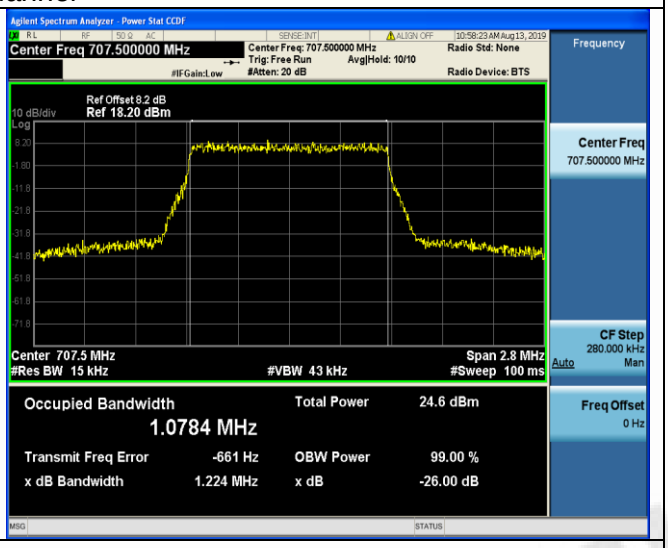
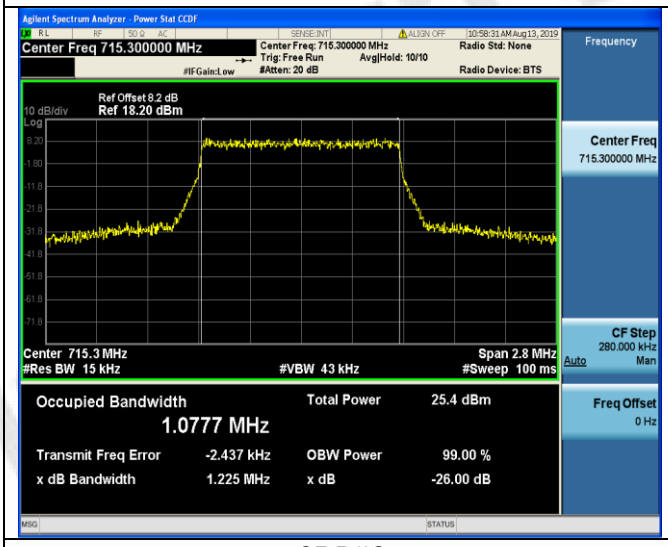
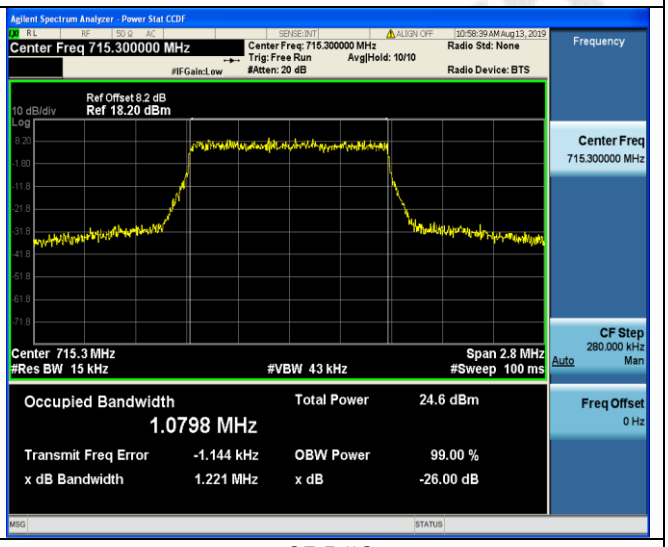
TEST PROCEDURE

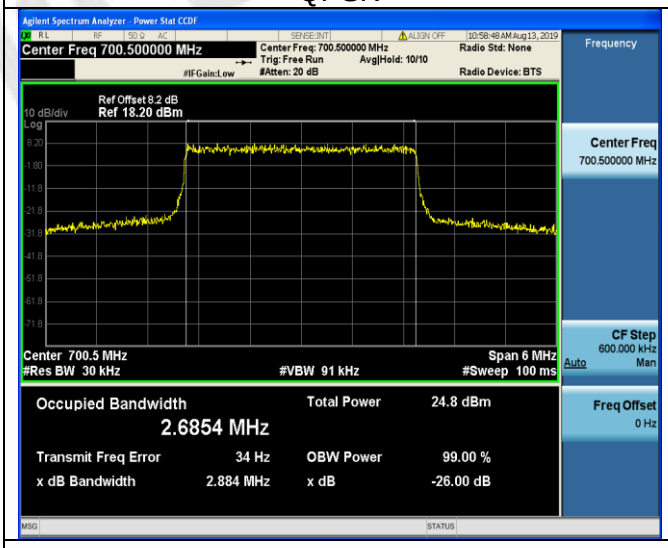
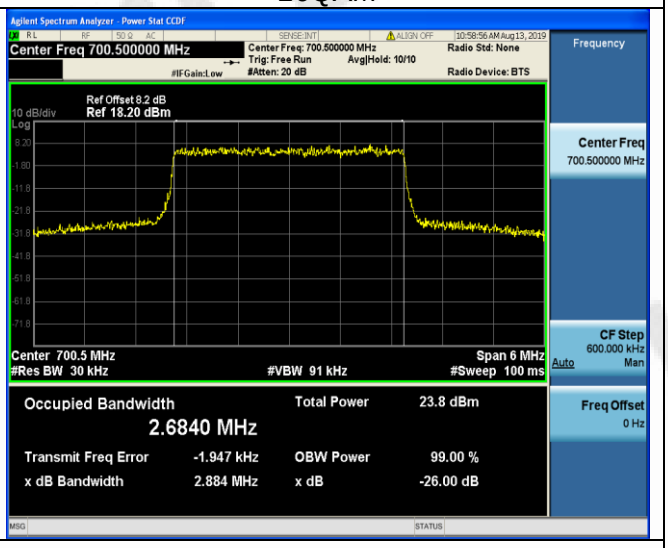
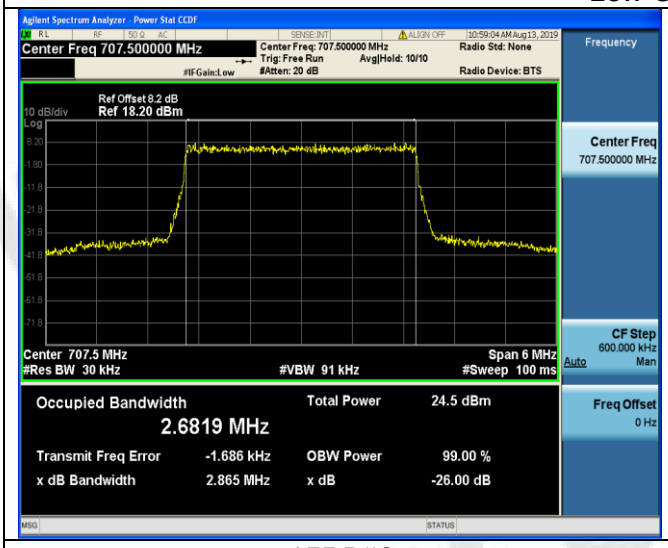
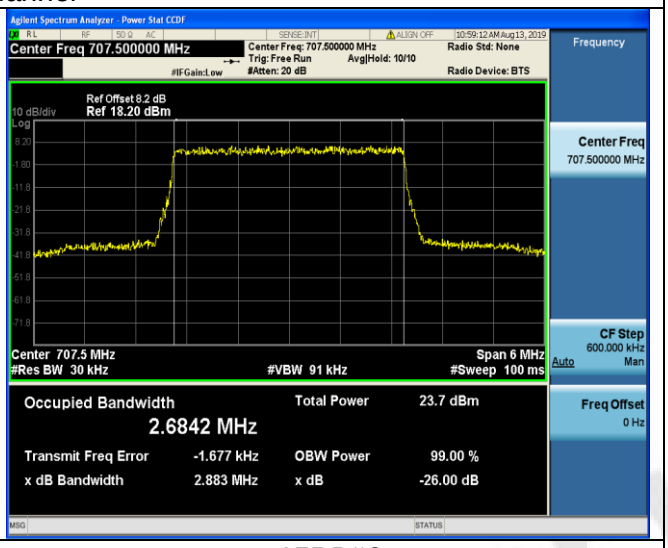
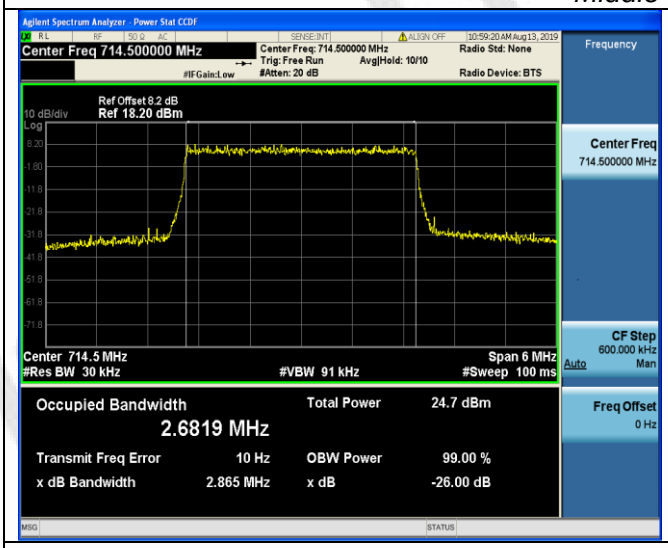
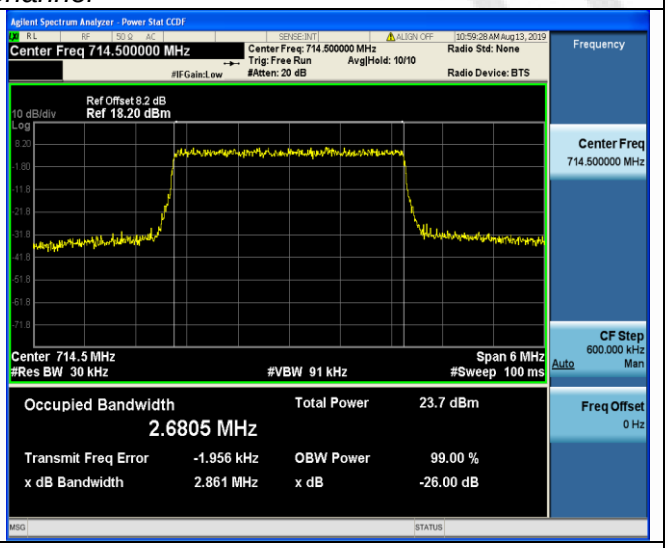
The transmitter output was connected to a calibrated coaxial cable and coupler, the other end of which was connected to a spectrum analyzer. The occupied bandwidth was measured with the spectrum analyzer at low, middle and high channel in each band. The -26dBc Emission bandwidth was also measured and recorded.
Set RBW was set to about 1% of emission BW, VBW≥3 times RBW.
-26dBc display line was placed on the screen (or 99% bandwidth), the occupied bandwidth is the delta frequency between the two points where the display line intersects the signal trace.

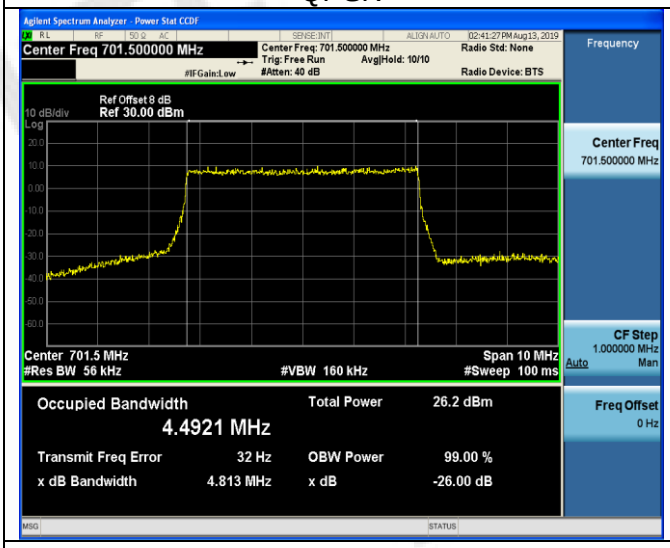
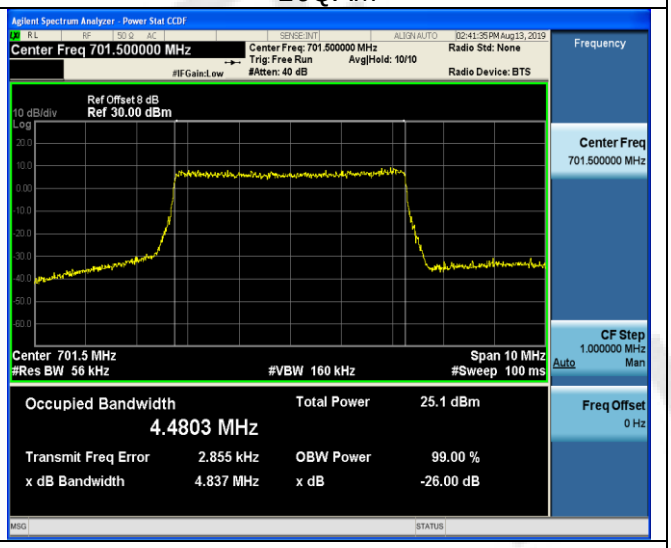
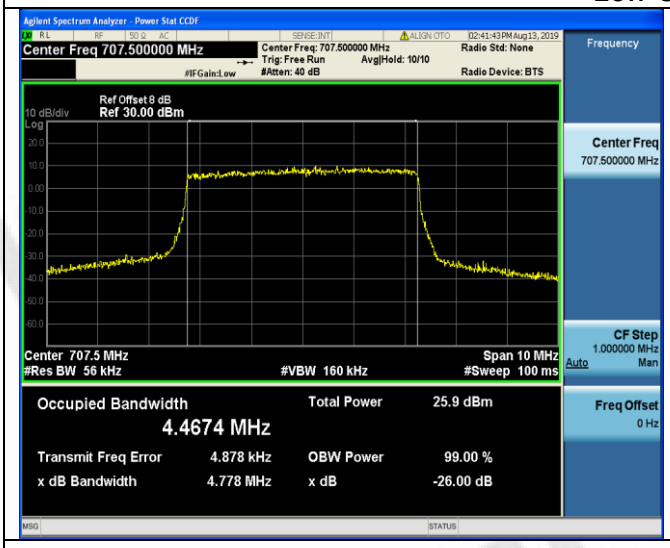
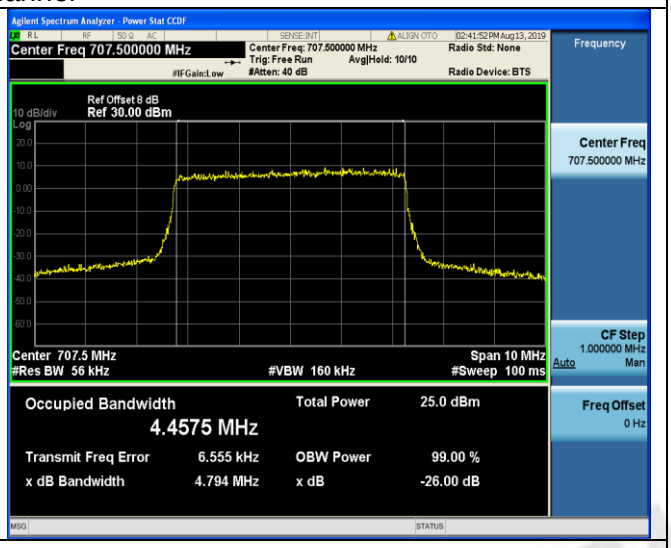
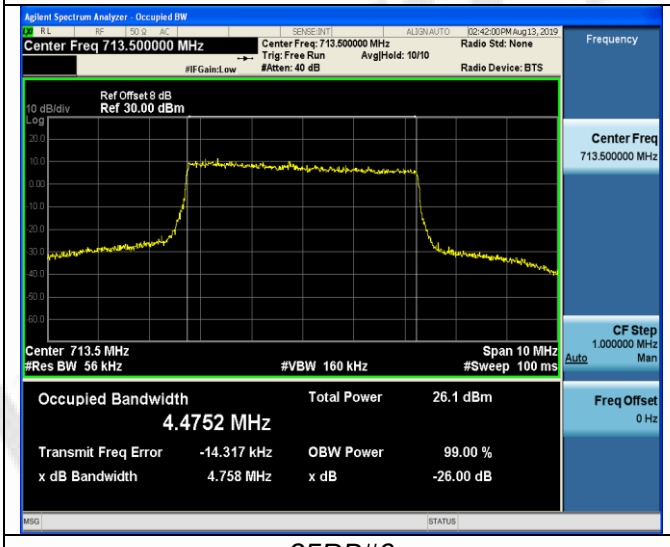
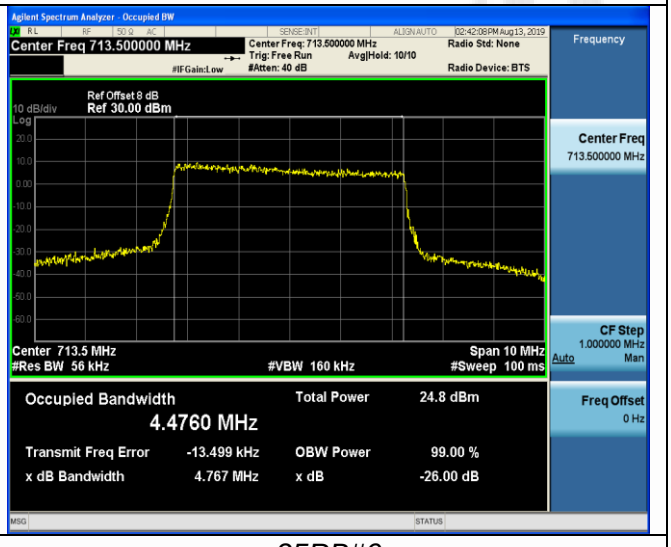
TEST RESULTS

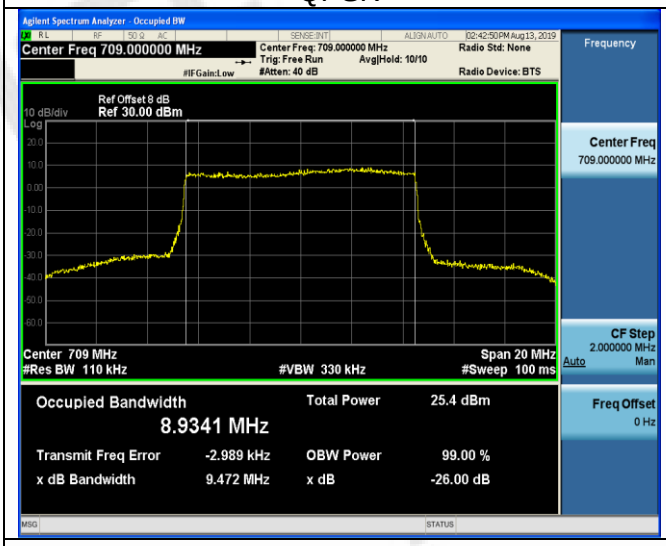
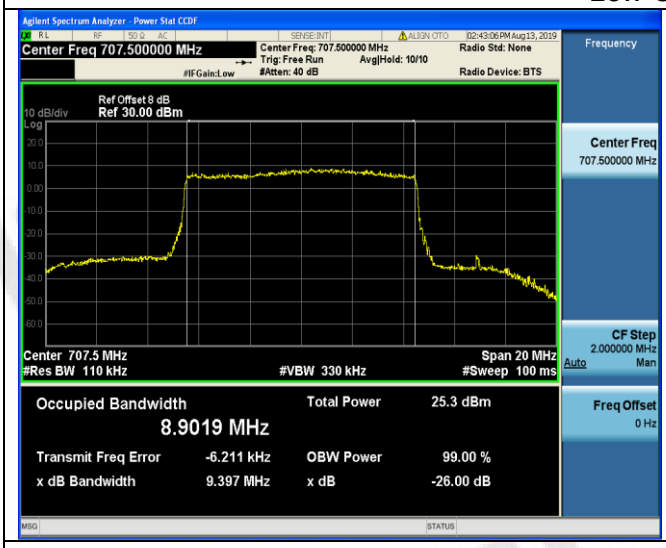
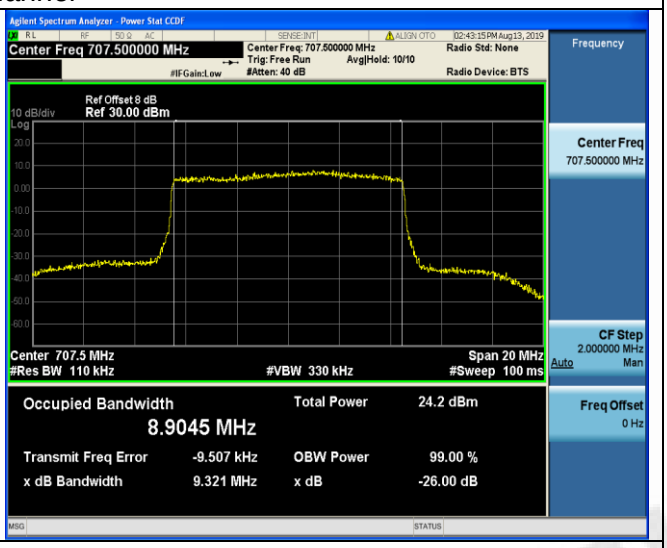
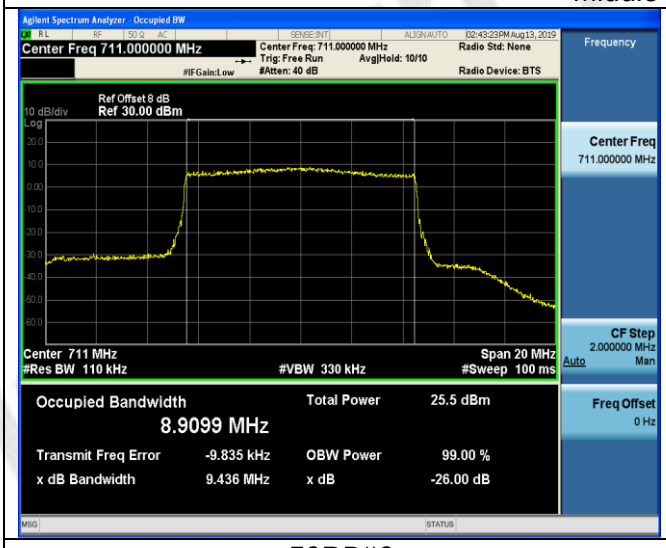
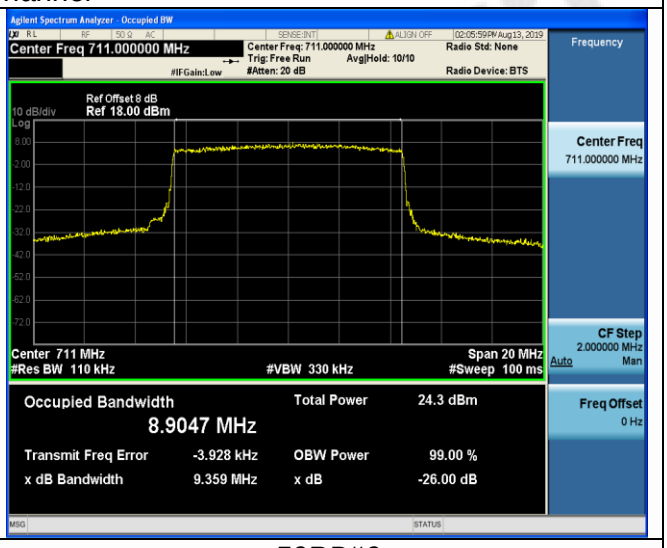
Remark:
1. *We were tested all RB Configuration refer 3GPP TS136 521 for each Channel Bandwidth of LTE FDD Band 12; recorded worst case for each Channel Bandwidth of LTE FDD Band 12.*

LTE FDD Band 12						
TX Channel Bandwidth	RB Size/Offset	Frequency (MHz)	-26dBc Emission bandwidth (MHz)		99% Occupied bandwidth (MHz)	
			QPSK	16QAM	QPSK	16QAM
1.4 MHz	*6RB#0*	699.7	1.226	1.245	1.0792	1.0811
		707.5	1.225	1.224	1.0768	1.0784
		715.3	1.225	1.221	1.0777	1.0798
3 MHz	*15RB#0*	700.5	2.884	2.884	2.6854	2.6840
		707.5	2.865	2.883	2.6819	2.6842
		714.5	2.865	2.861	2.6819	2.6805
5 MHz	*25RB#0*	701.5	4.813	4.837	4.4921	4.4803
		707.5	4.778	4.794	4.4674	4.4575
		713.5	4.758	4.767	4.4752	4.4760
10 MHz	*50RB#0*	704	9.472	9.438	8.9341	8.9291
		707.5	9.397	9.321	8.9019	8.9045
		711	9.436	9.359	8.9099	8.9047

LTE FDD Band 12-1.4MHz Channel Bandwidth	
QPSK	16QAM
	
6RB#0	6RB#0
Low Channel	
	
6RB#0	6RB#0
Middle Channel	
	
6RB#0	6RB#0
High Channel	

LTE FDD Band 12-3MHz Channel Bandwidth	
QPSK	16QAM
	
15RB#0	15RB#0
Low Channel	
	
15RB#0	15RB#0
Middle Channel	
	
15RB#0	15RB#0
High Channel	

LTE FDD Band 12-5MHz Channel Bandwidth	
QPSK	16QAM
	
25RB#0	25RB#0
Low Channel	
	
25RB#0	25RB#0
Middle Channel	
	
25RB#0	25RB#0
High Channel	

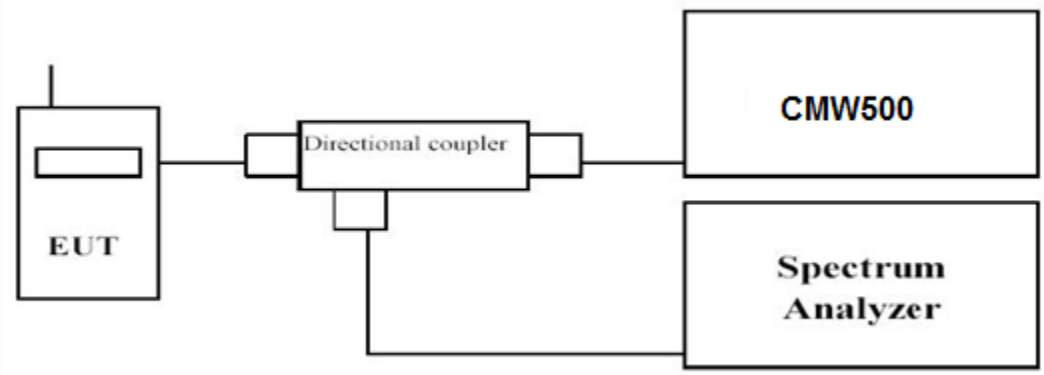
LTE FDD Band 12-10MHz Channel Bandwidth	
QPSK	16QAM
	
50RB#0	50RB#0
Low Channel	
	
50RB#0	50RB#0
Middle Channel	
	
50RB#0	50RB#0
High Channel	

3.4. Band Edge compliance

LIMIT

According to §27.53 (h): For operations in the 1710–1755 MHz and 2110–2155 MHz bands, the power of any emission outside a licensee's frequency block shall be attenuated below the transmitter power (P) by at least 43 + 10 log10(P) dB.

TEST CONFIGURATION



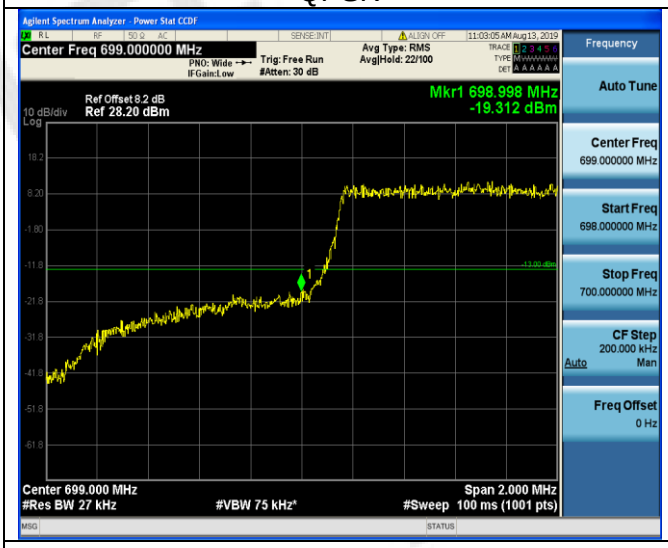
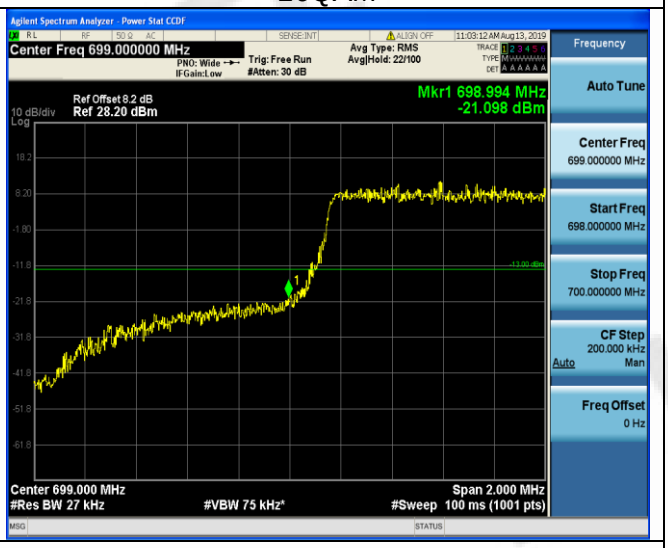
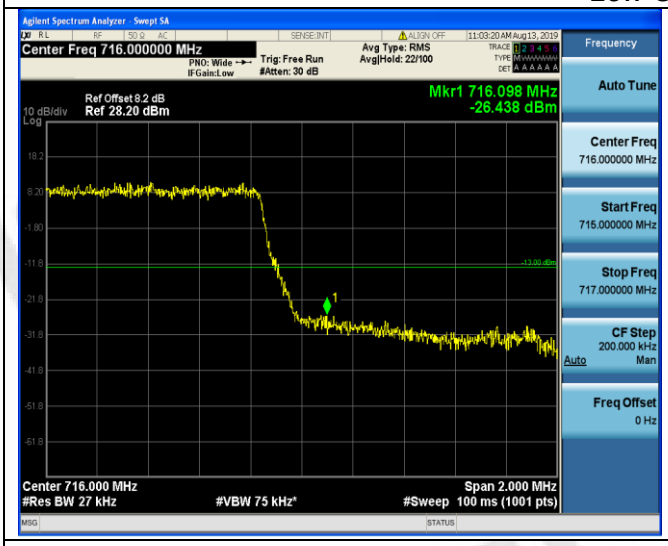
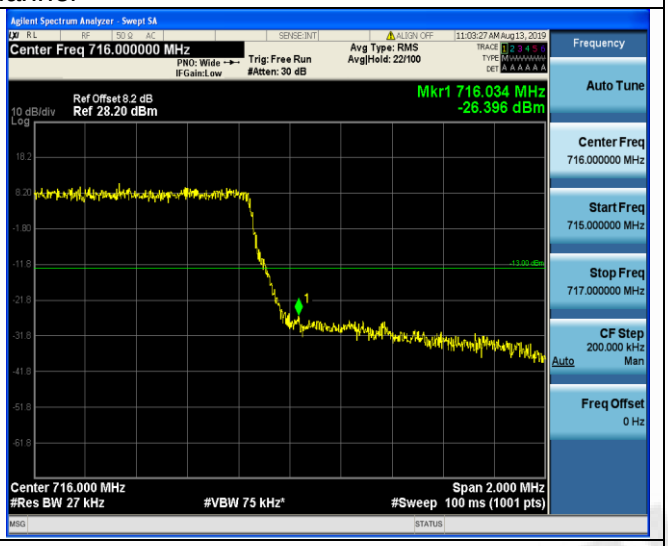
TEST PROCEDURE

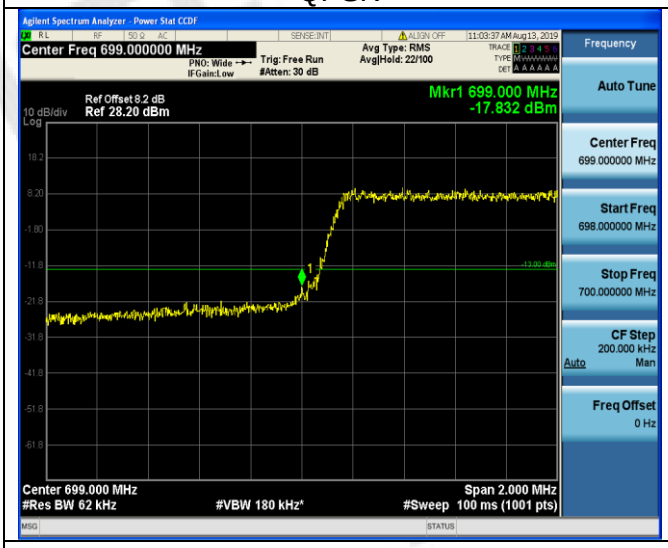
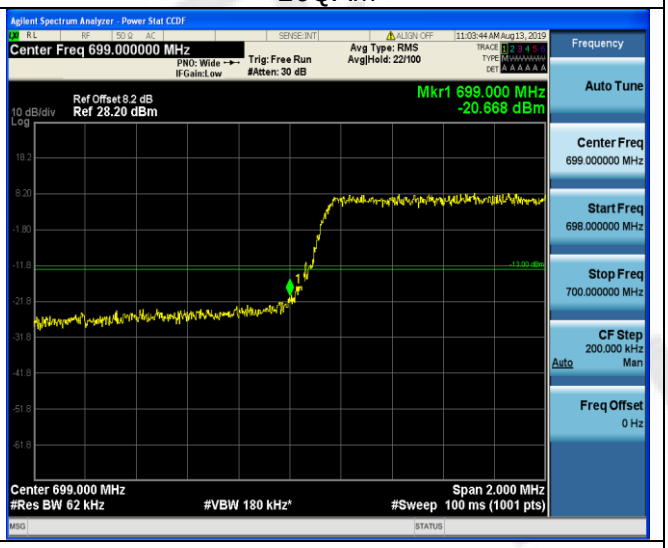
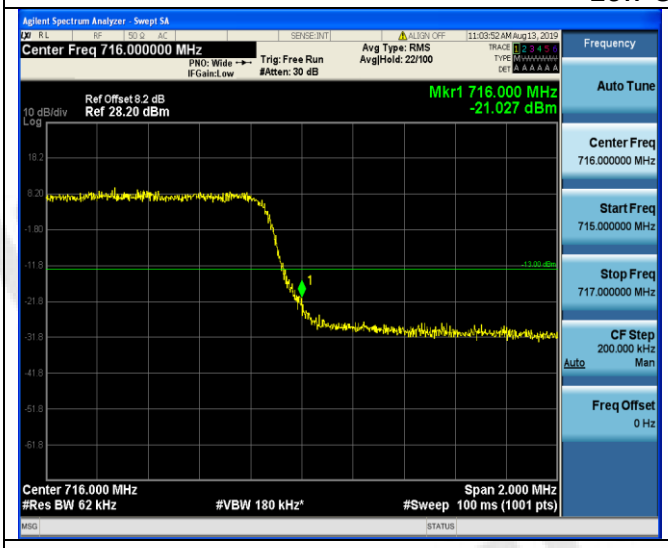
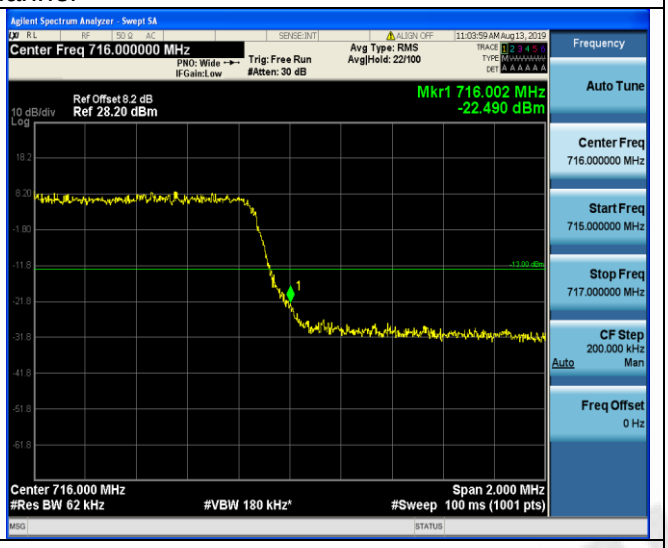
1. The transmitter output port was connected to base station.
2. The RF output of EUT was connected to the power meter by RF cable and attenuator, the path loss was compensated to the results for each measurement.
3. Set EUT at maximum power through base station.
4. Select lowest and highest channels for each band and different modulation.
5. Measure Band edge using RMS (Average) detector by spectrum

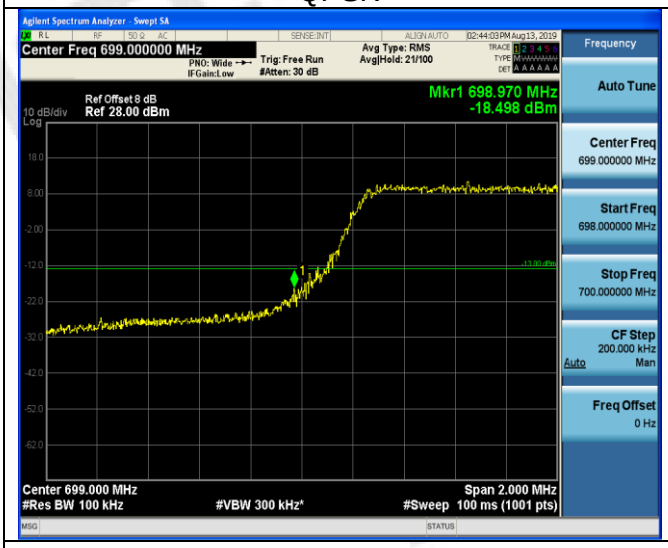
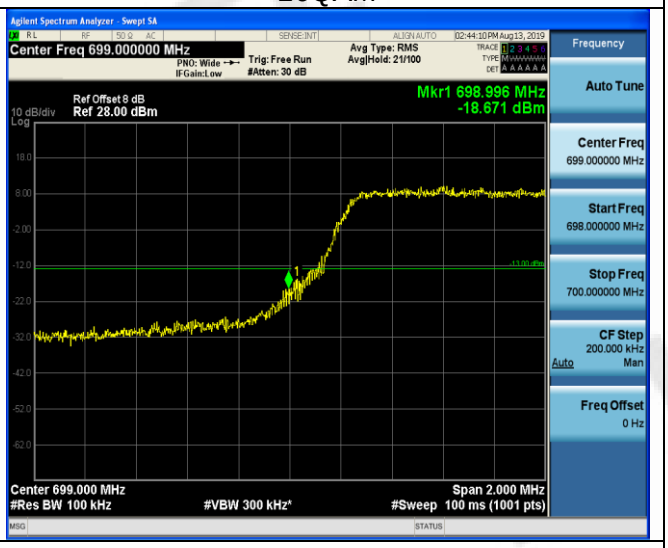
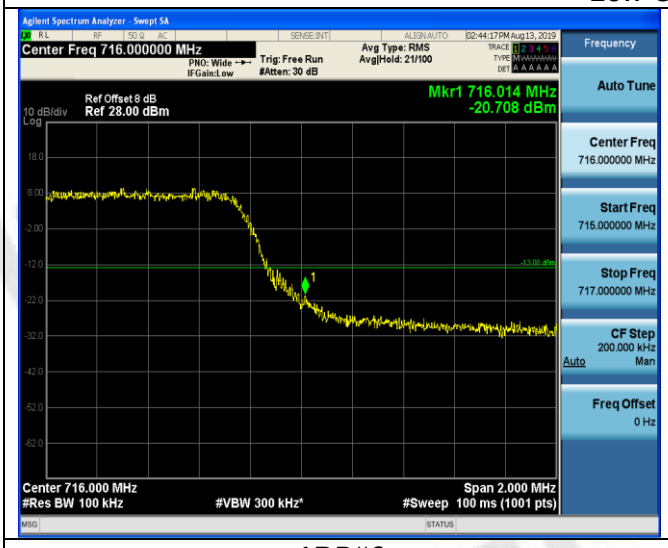
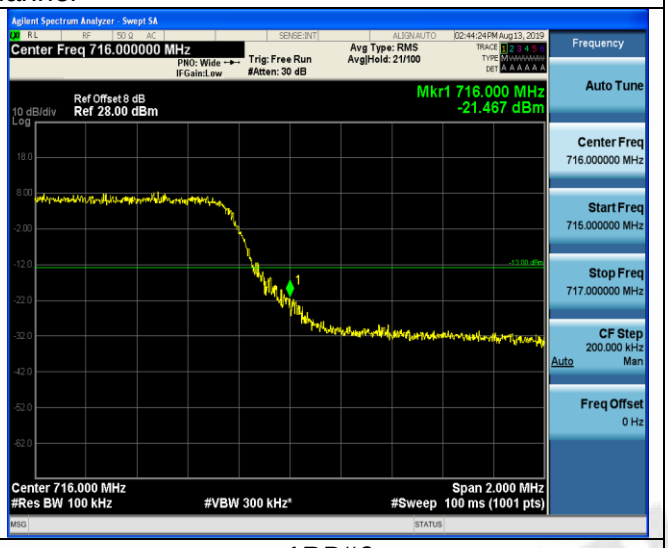
TEST RESULTS

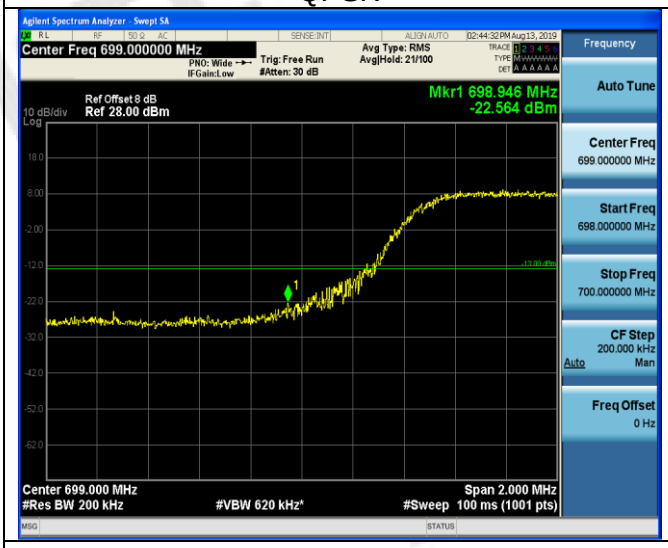
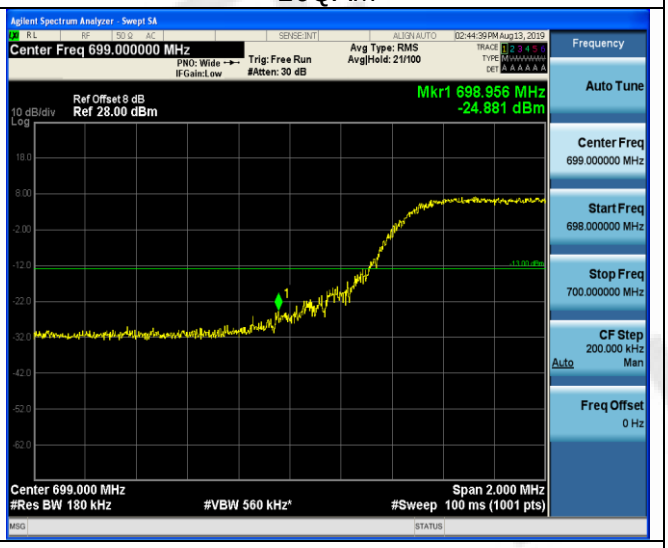
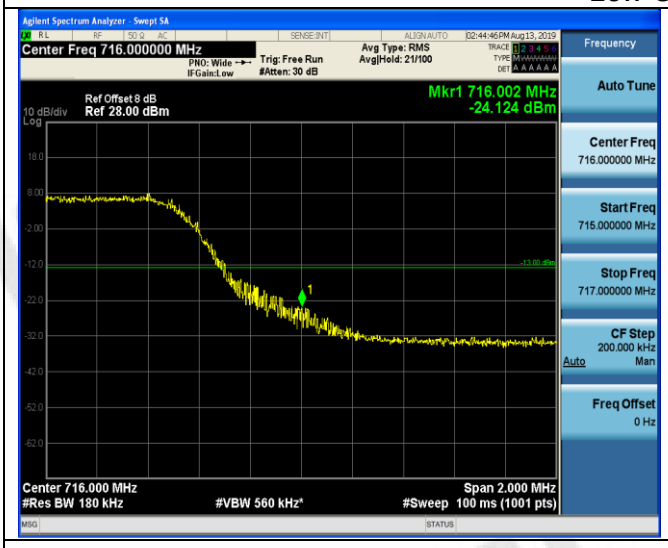
Remark:

1. *We were tested all RB Configuration refer 3GPP TS136 521 for each Channel Bandwidth of LTE FDD Band 12; recorded worst case for each Channel Bandwidth of LTE FDD Band 12.*

LTE FDD Band 12-1.4MHz Channel Bandwidth Band Edge Compliance	
QPSK	16QAM
	
1RB#0	1RB#0
Low Channel	
	
1RB#0	1RB#0
High Channel	

LTE FDD Band 12-3MHz Channel Bandwidth Band Edge Compliance	
QPSK	16QAM
	
1RB#0	1RB#0
Low Channel	
	
1RB#0	1RB#0
High Channel	

LTE FDD Band 12-5MHz Channel Bandwidth Band Edge Compliance	
QPSK	16QAM
	
1RB#0	1RB#0
Low Channel	
	
1RB#0	1RB#0
High Channel	

LTE FDD Band 12-10MHz Channel Bandwidth Band Edge Compliance	
QPSK	16QAM
	
1RB#0	1RB#0
Low Channel	
	
1RB#0	1RB#0
High Channel	

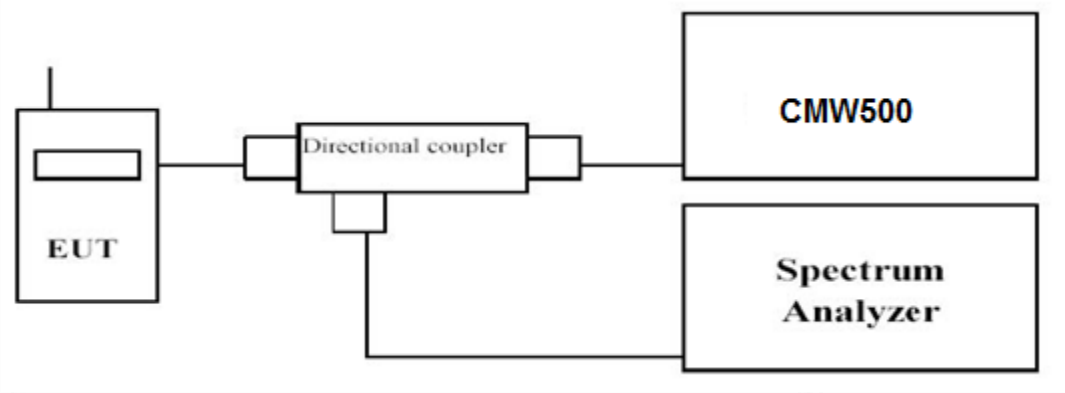
3.5. Spurious Emission

LIMIT

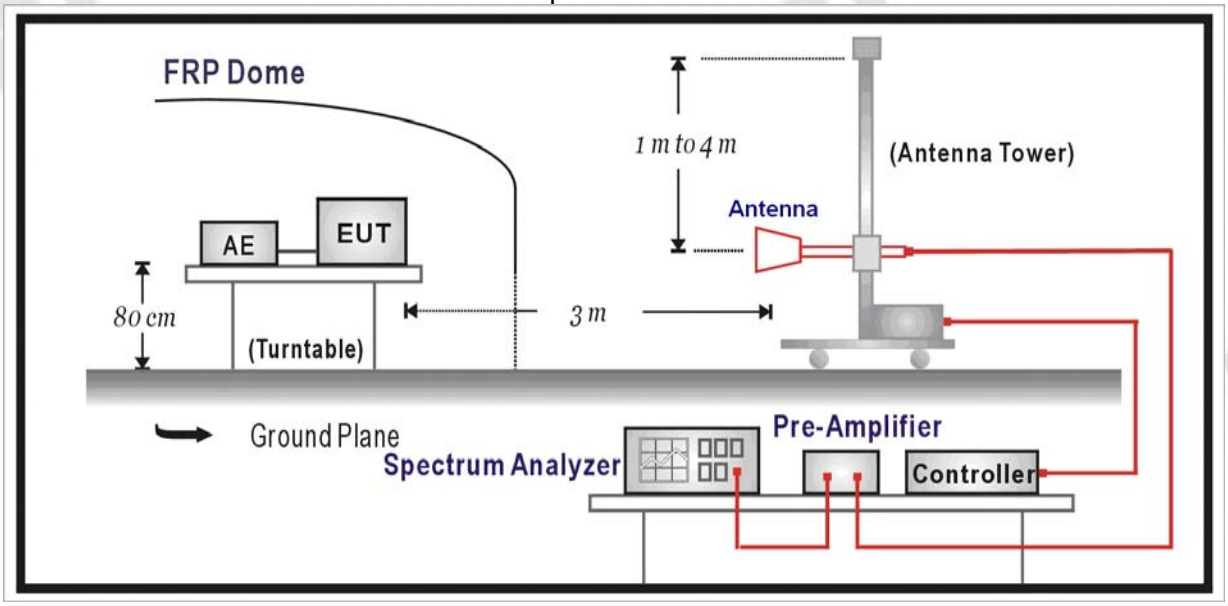
According to §27.53 (h): For operations in the 1710–1755 MHz and 2110–2155 MHz bands, the power of any emission outside a licensee's frequency block shall be attenuated below the transmitter power (P) by at least 43 + 10 log10(P) dB.

TEST CONFIGURATION

Conducted Spurious Measurement:



Radiated Spurious Measurement:



TEST PROCEDURE

The EUT was setup according to EIA/TIA 603D

Conducted Spurious Measurement:

a. Place the EUT on a bench and set it in transmitting mode.
b. Connect a low loss RF cable from the antenna port to a spectrum analyzer and CMW500 by a Directional Couple.
c. EUT Communicate with CMW500 then selects a channel for testing.
d. Add a correction factor to the display of spectrum, and then test.
e. The resolution bandwidth of the spectrum analyzer was set sufficient scans were taken to show the out of band Emission if any up to10th harmonic.